DESIGN OF LOW-POWER NRZ/PAM-4 WIRELINE TRANSMITTERS

A Dissertation

by

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ABSTRACT

Rapid growing demand for instant multimedia access in a myriad of digital devices has pushed the need for higher bandwidth in modern communication hardwares ranging from short-reach (SR) memory/storage interfaces to long-reach (LR) data center Ethernets. At the same time, comprehensive design optimization of link system that meets the energy-efficiency is required for mobile computing and low operational cost at datacenters. This doctoral study consists of design of two low-swing wireline transmitters featuring a low-power clock distribution and 2-tap equalization in energy-efficient manners up to 20-Gb/s operation. In spite of the reduced signaling power in the voltage-mode (VM) transmit driver, the presence of the segment selection logic still diminishes the power saving benefit.

The first work presents a scalable VM transmitter which offers low static power dissipation and adopts an impedance-modulated 2-tap equalizer with analog tap control, thereby obviating driver segmentation and reducing pre-driver complexity and dynamic power. Per-channel quadrature clock generation with injection-locked oscillators (ILO) allows the generation of rail-to-rail quadrature clocks. Energy efficiency is further improved with capacitively driven low-swing global clock distribution and supply scaling at lower data rates, while output eye quality is maintained at low voltages with automatic phase calibration of the local ILO-generated quarter-rate clocks. A prototype fabricated in a general purpose 65 nm CMOS process includes a 2 mm global clock distribution network and two transmitters that support an output swing range of 100-300mV with up to 12-dB of equalization. The transmitters achieve 8-16 Gb/s operation at 0.65-1.05 pJ/b energy efficiency.

The second work involves a dual-mode NRZ/PAM-4 differential low-swing voltage-mode (VM) transmitter. The pulse-selected output multiplexing allows reduction of power supply and deterministic jitter caused by large on-chip parasitic inherent in the transmission-gate-based multiplexers in the earlier work. Analog impedance control replica circuits running in the background produce gate-biasing voltages that control the peaking ratio for 2-tap feed-forward equalization and
PAM-4 symbol levels for high-linearity. This analog control also allows for efficient generation of the middle levels in PAM-4 operation with good linearity quantified by level separation mismatch ratio of 95%. In NRZ mode, 2-tap feedforward equalization is configurable in high-performance controlled-impedance or energy-efficient impedance-modulated settings to provide performance scalability. Analytic design consideration on dynamic power, data-rate, mismatch, and output swing brings optimal performance metric on the given technology node. The proof-of-concept prototype is verified on silicon with 65 nm CMOS process with improved performance in speed and energy-efficiency owing to double-stack NMOS transistors in the output stage. The transmitter consumes as low as 29.6mW in 20-Gb/s NRZ and 25.5mW in the 28-Gb/s PAM-4 operations.
DEDICATION

To my mother, my father, my wife, and my son.
"Looking unto Jesus, the author and finisher of our faith, who for the joy that was set before Him endured the cross, despising the shame, and has sat down at the right hand of the throne of God."—Hebrew 12:2 (NKJV)

During my years at A&M, it has been a great journey in my life. College Station has been my home. And, God willing, wherever I go, this town shall always remain my home in my heart. As I reflect upon my graduate studies, the words dedication, perseverance, hard work, sacrifice, faith, collaboration, camaraderie and love come to my mind. As we all know, for any man to accomplish something, he must have a team – a very incredible, special team; people that he can learn from, count on, and rely upon through everything – the highs and lows, the success and failure, and even the joy and sorrow that happen both in and out of the Wisenbaker Building.

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Lastly and most importantly, I want to give thanks and praise to Christ Jesus, my Lord. I know and realize without Him, I am nothing, so I give Him all the glory and honor as my doctoral study finally comes to an end. Thank you for the love, and the mercy, and the goodness you poured out upon me. Thank you for picking up when I stumbled. Thank you for getting me back on the right track when I strayed away. Thank you for teaching me how to love His sheep and to live life for His Kingdom and righteousness. Thank you, dear Lord.

As I close the final chapter of the dissertation, I confess and proclaim.

Soli Deo Gloria!
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Contributors

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NOMENCLATURE

SR  Short-Reach
LR  Long-Reach
VM  Voltage-Mode
ILO  Injection-Locked Oscillator
CMOS  Complementary Metal-Oxide-Semiconductor
I/O  Input and Output
TX  Transmitter
RX  Receiver
UHD  Ultra High-Definition
HPC  High-Performance Computing
TCO  Total Cost of Ownership
CPU  Central Processing Unit
DVFS  Dynamic Voltage and Frequency Scaling
PAM-4  Pulse Amplitude Modulation-4
PSD  Power Spectral Density
NRZ  Non-Return-to-Zero
BER  Bit-Error-Rate
NRE  Non-Recurring Engineering
GALS  Globally Asynchronous Locally Synchronous
ISI  Inter-Symbol Interference
FFE  Feed-Forward Equalization
FIR  Finite-Impulse Response
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<th>Abbreviation</th>
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<tr>
<td>LVDS</td>
<td>Low-Voltage Differential-Swing</td>
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<td>EMI</td>
<td>Electro-Magnetic Interference</td>
</tr>
<tr>
<td>MOSFET</td>
<td>Metal-Oxide-Field-Effect-Transistor</td>
</tr>
<tr>
<td>CM</td>
<td>Current-Mode</td>
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<tr>
<td>ESD</td>
<td>Electro-Static Discharge</td>
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<tr>
<td>AFE</td>
<td>Analog Front-End</td>
</tr>
<tr>
<td>CTLE</td>
<td>Continuous-Time Linear Equalizer</td>
</tr>
<tr>
<td>SNR</td>
<td>Signal-to-Noise Ratio</td>
</tr>
<tr>
<td>MLS</td>
<td>Multi-Level Signaling</td>
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<tr>
<td>DT</td>
<td>Discrete-Time</td>
</tr>
<tr>
<td>DFE</td>
<td>Decision Feedback Equalizer</td>
</tr>
<tr>
<td>IIR</td>
<td>Infinite-Impulse Response</td>
</tr>
<tr>
<td>MSB</td>
<td>Most-Significant Bit</td>
</tr>
<tr>
<td>CDR</td>
<td>Clock and Data Recovery</td>
</tr>
<tr>
<td>PLL</td>
<td>Phase-Locked Loop</td>
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<tr>
<td>PC</td>
<td>Phase Calibration</td>
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<tr>
<td>DJ</td>
<td>Deterministic Jitter</td>
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<tr>
<td>HP</td>
<td>High-Performance</td>
</tr>
<tr>
<td>EE</td>
<td>Energy-Efficient</td>
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<tr>
<td>DCC</td>
<td>Duty-Cycle Correction</td>
</tr>
<tr>
<td>QEC</td>
<td>Quadrature Error Correction</td>
</tr>
<tr>
<td>PRBS</td>
<td>Pseudo-Random Bit Sequence</td>
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<tr>
<td>LSB</td>
<td>Least-Significant Bit</td>
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<tr>
<td>PVT</td>
<td>Process, Voltage, and Temperature</td>
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<tr>
<td>STA</td>
<td>Static Timing Analysis</td>
</tr>
<tr>
<td>Acronym</td>
<td>Description</td>
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<tr>
<td>MDB</td>
<td>Multi-Drop Bus</td>
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<tr>
<td>GCPWG</td>
<td>Grounded-Coplanar Waveguide</td>
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1. INTRODUCTION

1.1 Low-power high-speed I/O system

A rapid growing demand for instant multimedia access in a myriad of digital devices has pushed the need for higher bandwidth in modern digital communication hardwares ranging from short-reach (SR) memory/storage interface to long-reach (LR) data center Ethernets. The average rate per capita of data-driven interactions with cloud service, ultra high-definition (UHD) video streaming, mobile computing, machine-generated data (e.g. autonomous vehicles, security image, etc) are expected to increase 20-fold in the next 10 years [10], creating the need to double the bandwidth demand in the datacenter every 2-3 years.

Energy efficiency is the topmost performance goal in the design of modern wireless communication devices. In mobile computing, it is essential to extend battery and miniaturize devices for portability as the improvement in battery capacity has not kept up with silicon technology. Energy efficiency is even more of an issue for large scale high-performance computing (HPC) as it is essential to reduce the operational costs of powering data centers as well as to maintain HPC system reliability [11]. Keeping a large scale data center produces egregious heat that requires continual cooling in a large server room, thus resulting in substantial total cost of ownership (TCO) of a HPC server. As shown in Figure 1.1, the largest expenditure on energy bill comes from cooling [1]. Optimizing the power management or minimizing heat generation of the devices will bring a large benefit of reducing energy.

Input and output (I/O) interface power in HPC system linking servers/storage or further utilizing cross-connecting data centers are known to be one of the biggest bottleneck in meeting the bandwidth demand. While the performance of cutting-edge electronic circuits such as central processing unit (CPU) and memory system has been improved exponentially according to the Moore’s law, packaging devices so called "off-chip devices" (i.e chip bonding, silicon interposer, coerpper channels, connectors, etc) could not pace with "on-chip" domain [12].
Supporting the dramatic growth in high-performance and mobile processorsâ€™ I/O bandwidth [13, 14] requires per-channel data rates to increase well beyond 10 Gb/s due to packaging technology allowing only modest increases in I/O channel count. At these relatively high data rates, complying with thermal design power limits in HPC systems and battery lifetime requirements in mobile platforms necessitates improvements in I/O system energy efficiency [15, 16] and dynamic power management such as the dynamic voltage and frequency scaling (DVFS) algorithm. Scaling the power supply voltage with data rate is an effective technique to achieve nonlinear dynamic power-scaling at reduced-speeds [17, 18]. In order to improve I/O energy efficiency at high data rates, improvements in static and dynamic power consumption are required in a manner that allows for robust operation at both low-voltage and with the growing mismatch found in nanometer CMOS technologies.

1.2 Pulse Amplitude Modulation-4 (PAM-4)

It has been a much debated issue among standard study groups on how to increase the throughput of high-density link up to 400-Gb/s [19]. Multi-level signaling (MLS) allows multiple data
Figure 1.2: (a) NRZ signaling (1-Main, 1-Post), (b) PAM-4 signaling (Gray code, No Equalization).

bits encoded into a symbol with the same time-frame. PAM-4, which could become the last resort for achieving 400-Gb/s data-center Ethernet interconnects, is likely to become a mainstream high-speed serial interfaces such as FibreChannel. There is a strong trend in the adoption of PAM-4 modulation scheme in many high-speed data network systems as shown in Figure 1.3. PAM-4 requires half the bandwidth to transmit the same amount of data as the equivalent NRZ throughput as seen in Figure 1.2. Another advantage is that high data-rate operation on legacy backplane system can be more successful with the PAM-4 resulting in lower return loss. For example high throughput operation using PAM-4 can be achieved with only half as Nyquist frequency as that of NRZ without experiencing the big notch band. So, It is worthwhile to consider the PAM-4 operation on inexpensive legacy backplane channels for the same throughput.

Meanwhile, the number of I/O count continues to grow to keep up with faster processor and memory speed. As PAM-4 doubles the number of bits per symbol at the same baud rate as NRZ coding, crosstalk that occurs in high-density I/O designs with closely spaced signal routing and vias could be relaxed with wider spacing in PAM-4 operation. For PAM-4 modulation the average transition density (TD) is 75% whereas the average TD of NRZ is 50%. Therefore the crosstalk effect becomes more severe when PAM-4 modulation is utilized. To make the matter worse, full-
swing aggressor can produce higher noise to victim channels due to the tighter spacing between voltage levels.

1.3 Multi-Protocol I/O

As illustrated in Figure 1.4, various wireline I/O standards exist with similar, but different specifications. Each wireline I/O standard is a market driving force that can give the most competitive solution for a predefined application and ensure interoperability. If the ASIC vendors build custom designs to-spec for every application, however, development time-to-market and cost associated with it will rise. As a matter of course, however, compared to single-protocol links, multi-protocol serial links incur high development cost and complexity, and usually suffer from performance and efficiency drawbacks. If performance and power efficiency are kept above acceptable levels imposed by different standards, multi-standard links will gain market opportunities thanks to IP reuse. The trend of multi-protocol I/O will foster the need for adaptation of TX and RX equalizer tap weights to achieve the target bit error rate (BER) while operating through various channels specified in each standard.

As an extensive multitude of redundant building blocks between NRZ and PAM-4 codings could be reused for each other, supporting dual-mode schemes in a single IP will gain market
opportunity by lowering development time to market and nonrecurring engineering (NRE) cost [20, 21]. Additionally, featuring scalable performance/power will augment interoperability between various applications. Furthermore, it can also thrive from a trend of adopting ADC-based wireline receivers that support advanced DSP modulation on line data and provide compatibility with multi-level coding. Also, the use of multi-standard can thrive from multi-level signaling such as PAM-4 which yields 1/2 baud-rate. A research trend of ADC-based wireline receivers will provide compatibility with transmitter as a fine granularity DAC.

1.4 Dissertation Organization

With the emphasis on the increasing demand on power-efficient high-speed I/O link system and growing interest in multi-level signaling such as PAM-4 in this chapter, the Chapter. 2 will move
onto the fundamental of the electrical wireline I/O transceiver systems and circuits particularly on equalization and low-power design.

Starting in Chapter 3, a low-power scalable-data-rate voltage-mode transmitter is featured. It introduces two main innovations. First, an impedance-modulated 2-tap equalizer is adopted that employs analog control of the equalizer taps, thereby obviating output driver segmentation. Secondly, capacitively driven low-swing global clock distribution and automatic phase calibration of the local ILO-generated quarter-rate clocks enables improved energy efficiency with aggressive supply scaling.

Another research project discussed in the Chapter 4 is improved upon the low-swing VM transmit equalizer with impedance control that further expand its capability of generating PAM-4 signal. Particular emphasis is given to advantage of pulse-selected output multiplexing. And some of the power-saving techniques will be explained with design consideration to keep in mind. The final chapter concludes this dissertation with some of the future work in progress.
2. REVIEW ON LOW-POWER WIRELINE TRANSCEIVERS

2.1 Low-power-aware design

Energy-efficiency is one of the most important performance goal in modern I/O link systems. The dynamic power consumption in the digital CMOS circuits originates from switching activity of logic gates inside I/O link system shown in Figure 2.1 as given by,

$$P_{\text{switching}} = aC_L V_{DD}^2 f$$ (2.1)

where $C_L$ is the loading capacitance at the output node, $V_{DD}$ is the digital supply voltage, $f$ is the frequency, and $a$ is the activity factor indicating a switching probability of power-dissipating transitioning occurs [22]. In the transmitter the pre-driver stage is the most power dissipating block as it is the buffer stage to the output driver responsible for generating voltage swing on low impedance termination. At the receiver, the incoming signal is sampled, regenerated to CMOS logic level before being deserialized. For common latches (e.g. StrongArm comparator) used in receiver’s front-end the eq.(2.1) still holds.

Power consumption in digital circuits can be reduced in several ways. Internal capacitance

Figure 2.1: Simplified high-speed digital wireline I/O (Dynamic power consuming building blocks highlighted in color).
could be usually reduced by technology scale-down. Parallelism is often a solution in many application to cut the clock frequency down. However, it would add interconnect complexity which will offset the overall dynamic power. Supply reduction allows quadratic saving of dynamic power. However, that slows digital circuits. There has been a number of efforts to reduce the activity factor with techniques such as clock gating and request-driven globally asynchronous locally synchronous (GALS) technique [23].

2.2 Equalization

Many practical channels are bandwidth-limited and linearly distort the transmit signal in high-speed digital communication. The dispersive nature of the channel causes significant spreading of data pulse. The phenomenon commonly, called inter-symbol interference (ISI) is a dominant impairment for signal integrity in high-speed wireline communication system as shown in Figure 2.2. In order to mitigate the ISI on the bandwidth-limited physical medium, various equalization methods are used in both transmitter and receiver. The research goal in this work is to design the energy-efficient transmit/receiving equalizers.
2.3 Transmitter design

To mitigate the effect of ISI, equalization methods are often used in digital communication. Applying FIR filter, the feed-forward equalization is popular in the transmitter side. Shown in Figure 2.4, the 2-tap equalization with one main- and post-cursor can mitigate frequency dependent loss by predistorting the subsequent bit before transmitting into the channel. As shown in the pulse response where one logic 1 surrounded by logic 0s is sent, ISI is eliminated by pre-emphasizing alpha amount whenever the data transitions. Hence, the post-cursor due to the ISI is suppressed.
The single most commonly used equalization method at the transmitter is the feedforward equalizer (FFE). Figure 2.3 presents the block-diagram of (N+M+1)-tap FFE. The input signal is fed through multiple delay line along with previous and future bits. These bits linearly summed with weighted tap coefficients \([c_N, c_{N-1}, \ldots, c_0, \ldots, c_{M-1}, C_M]\) are multiplied to delayed bits.

\[
x_{tx}(t) = \sum_{i=1}^{N} c_i x(n - i) + c_0 x(n) + \sum_{j=1}^{M} c_j x(n + j)
\]  

(2.2)

where the summation of all coefficients is one such that,

\[
\sum_{k=-N}^{M} |c_k| = 1
\]

(2.3)

The largest coefficient, \(c_0\) is called main tap, while those with smaller coefficient multiplied by the previous and future bits are pre-cursor and post-cursor taps, respectively. The number of coefficients and their values are chosen to compensate the precursor and postcursor that are dependent on target application, throughput, and electrical channel.

Ideally, high-speed link transmitter should support a pre-emphasis equalization with fine granularity and output swing control without altering termination impedance usually set by 50-Ω single-ended equivalent. The impedance of the transmit driver needs to match the channel impedance to prevent signal reflection and thus achieve low return loss.

Assuming a standard two-tap high-pass FIR filter with a negative postcursor tap \([-\alpha, -\alpha]\), the equalization peaking ratio \(\alpha\) is, by definition,

\[
\alpha = \frac{1}{2} \left(1 - \frac{V_{ppd,min}}{V_{ppd,max}}\right)
\]

(2.4)

and the amount of equalization peaking is

\[
EQ[dB] = 20 \log_{10} \left(\frac{1}{1 - 2\alpha}\right)
\]

(2.5)

It is important to define the output swing level and power of transmit drivers as a function of
channel loss. To transmit data on channels with high loss profile (such as CEI-25G-LR, IEEE 802.3bj, and InfiniBand EDR), transmit drivers that support high peak swing are valid candidates with moderate power consumption at the output stage [24]. On the other hand, the cost of power can be reduced with low output swing (< 1/2VDD) transmitters [3, 4, 5, 25, 26] under sufficient data recovery capability at the receiver. In addition to the low-power advantage, the low voltage differential swing (LVDS) presents another benefit over high-swing output voltage. Device generated electromagnetic interference (EMI) which is dependent on frequency, output voltage, and slew rate can be reduced in the LVDS I/O [21, 27]

2.3.1 Current-Mode Transmit Equalizer

For many high performance low output swing transmitters current mode (CM) output driver is commonly used. This structure forms a Norton-equivalent parallel termination. As seen in the Figure 2.5a, this CM structure allows for FIR filter which performs FFE by simply splitting differential branches with independent control according to equalizer weights and making impedance matching with passive linear resistor for varying output swing. The output swing and de-emphasis can be programmably adjusted by tail current source and the desired number of differential input pairs. When bandwidth extension techniques such as inductive peaking are utilized in the current
mode driver, high-bandwidth operation as high as 56 Gb/s could be achieved [28]. However, due to the resonance with high-Q inductance, the target applications are limited to narrow band.

While the CM drivers are still preferred structure for transmitters operating above 30 Gb/s per lane, the design of CM drivers for sufficient output swing have become more challenging as the nominal supply voltage has decreased in modern CMOS technology node. The CM transmit equalizer requires enough compliance voltage to keep the differential pair and current source in saturation for linearity. Therefore, the transistors used in the CM drivers are usually sized large enough to fully steer the current between the differential pair. This requires strong pre-driver stage with dominantly large power consumption at the high-speed. That also induces large parasitic capacitance with heavy routing at the output nodes to sustain current and has adverse effect on high speed operation

2.3.2 Voltage-Mode Transmit Equalizer

The quest for improved linearity and power efficiency raised interest in the use of VM transmitters in NRZ primarily due to their potential to consume 4x less power than CM counterparts [29, 30, 4, 31, 32]. Significant static power savings are possible by utilizing low-swing voltage-mode drivers for targetting short-range (SR) on-board chip-to-chip interconnect with channel loss limited to 15dB at half the symbol rate [33, 16, 3, 25]. For low impedance of channel (typically 50 Ω single-ended equivalent), the VM transmit driver utilize the metal-oxide semiconductor field-effect transistors (MOSFETs) as matching elements which should be usually large. In addition, it is challenging to utilize MOSFETs as matching devices in the triode region where they behave non-linearly and substantially vary on-resistance across process, voltage, and temperature (PVT) corners. This led to an idea utilizing a replica-bias circuit running in the background and tracking environmental change such as temperature [26]. Gate voltages generated by the replica that emulate the transmit driver’s signal path force the transmitter to have the same impedance as the replica circuit. In order to calibrate both pull-up and pull-down resistance, however, it needs to be able to compare the voltages at both polarities.

While CM driver is relatively easy to realize a FIR filter structures at the transmitter by sum-
ming the outputs of parallel current-mode stages weighted by the filter tap coefficients onto the channel and a parallel termination resistor [17], voltage-mode implementations are more difficult with the Thevenin equivalent series termination control. As shown in Figure 2.6, VM typical transmit drivers made of driver segments connected in parallel that are switched on or off by selection logic to adjust TX driver impedance. The output impedance cannot be calibrated independently of the equalization setting because the change in the number of parallel connected segments also affect the number of segments assigned to each tap. These topologies often set the equalizer taps’ weighting via output stage segmentation [4, 5, 3, 25], which adds complexity to the high-speed predriver circuitry and degrades the transmitter dynamic power efficiency.

As seen in the Figure 2.6, each segmented output driver elements are driven by pre-driver stage running at full data-rate. Equalization setting of the VM transmit drivers in general are achieved by assigning slices to each tap weight. Even larger MOSFETs may be needed to realize small offset for fine FFE tuning, resulting in the power and area overhead. The increased number of selection logic segments followed by pre-drivers will results in larger switching load capacitance, and thus increased dynamic power consumption.

One of the earliest VM transmit equalizer designs incorporating 2-tap equalization was implemented by creating a voltage-divider path between VREF to GND [30]. When the data transitions to opposite polarity, full swing of the output voltage is generated by the parallel combination of the RP and RN in this equivalent circuit diagram as shown in Figure 2.6a. The segment selection logic takes full-rate input data and 1-UI delayed data to encode associated impedances with parallel combination. The differential output voltage level is de-emphasized by creating a voltage divider from VREF to GND. In a parallel combination of RP and RN the impedance is terminated to the impedance of channel. The major issue from this topology, however, stems from its inefficient signaling power. The static current used in the output driver is

\[ I_{\text{sig}} = \frac{V_{\text{ref}}}{4R_T}\left\{1 + 4\alpha \left(1 - \alpha\right)\right\} \]  

(2.6)

where \( I_{\text{sig}} \), \( R_T \), and \( \alpha \) are static signaling current drawn from a voltage regulator, termination
resistance, and equalization peaking ratio, respectively. We can see from (2.6), the signaling power increases as the signal is de-emphsized.

In order to tackle this signaling power-inefficiency from the conventional VM transmit equalizer, an alternative type of driver is reported to maintain constant current for de-emphasis of output voltage swing (Figure 2.6b). Extra path in parallel with differential channel is used in order not to waste current for de-emphasis [4]. Therefore,

\[ I_{\text{sig}} = \frac{V_{\text{ref}}}{4R_T}. \]  

(2.7)

The total supply path impedance can be held constant to match the channel impedance. The resulting current stays constant for all output voltage swing as seen in (2.7). However, extra path create another set of segmentation for impedance control. Because of highly non-linear impedance mapping, decoding and predriver complexity becomes higher than conventional shunt path VM transmit equalizer. At the full data rate digital power becomes higher in this transmit driver [4, 25].

To reduce the signaling power, the most effective method is to use the least current for the data run-length greater than one producing the de-emphasised output. The impedance modulated transmit equalizer shown in Figure 2.6c, the output swing is determined by the voltage divide ratio between the driver’s output impedance and the receiver’s differential termination impedance.

\[ I_{\text{sig}} = \frac{V_{\text{ref}}}{4R_T} (1 - 2\alpha) \]  

(2.8)

By the impedance modulation driver’s output impedance de-emphasized signal output is generated. When the matching constraint is removed, the least current will be drawn for the lowest swing. In practice, a channel termination will never be 50-Ω single-ended equivalent. By increasing the total supply path impedance can sacrifice the impedance matching to the channel. With environmental change in the channel and imperfect matching due to parasitic elements (e.g., ESD capacitance, bond wire, packaging etc.), however, reflections will exist in the channel and they will
Figure 2.6: Low-swing voltage-mode transmit drivers with (a) segmented voltage divider [3], (b) with shunting resistor network [4], (c) with impedance modulation [5].
degrade return loss and increase in ISI if the output impedance of the transmit driver is not matched to the channel and does not absorb them [5]. In spite of the reduced signaling power, the presence of the segment selection logic still diminishes the power saving benefit.

2.4 RX

In contrast to transmitters that deliver the known data through channel, receivers do not know the data a priori but need to recover the digital message in the first place. While the challenging condition for the transmitter includes its requirement of driving a relatively low impedance of channel for sufficient swing, the receiver generally takes signal from the terminated input such that more efficient hardware implementation could be made at the analog front-end (AFE) due to the higher input impedance level.

As the I/O density has increased with increasing HPC power, back-channel through which optimized TX equalization setting is updated becomes unaffordable. While the transmitter can support the straightforward FFE, real-time adaptation of the the equalization in the RX without having to receive test pattern from TX and to send updated TX equalization settings upon evaluation of raw waveform is attractive. Therefore, the equalization burden can be shared with receiver.

2.4.1 Continuous-time linear equalization

Since dispersive electrical channels often introduce ISI from their low-pass filtering response, an inverse high-pass transfer function can effectively flatten the channel’s insertion loss such that the receiver can receive well-defined signal. An analog circuit known as the continuous-time linear equalizer (CTLE) can compensate channel loss by yielding a zero from the digitally programmable source-degenerated resistor and capacitor as shown in Figure 2.7a [6]. The $C_S$ reduces the impact of source degeneration and effectively boost magnitude response at high frequencies.

The transfer function is derived as

$$H(s) = \frac{g_m}{C_P} \left( \frac{s}{s + \frac{1}{R_S C_S}} \right) \left( \frac{1}{s + \frac{1}{R_D C_P}} \right)$$

(2.9)
where the discrete poles and zero are located at

\[ \omega_z = \frac{1}{R_S C_S}, \quad \omega_{p1} = \frac{1 + g_m R_S}{R_S C_S}, \quad \text{and} \quad \omega_{p2} = \frac{1}{R_D C_P}, \]

respectively. The DC gain and peaking ratio are

\[ A_{DC} = \frac{g_m R_D}{1 + g_m R_S} \] (2.11)

and

\[ \frac{\omega_{p1}}{\omega_z} = 1 + g_m R_S, \] (2.12)

respectively.

As the resistive source degeneration inherently manifest the reduced gain for enhanced linearity, the CTLE’s high-pass filtering is mimicked by suppressing the low-frequency gain rather than boosting the high-frequency gain. From the perspective of signal-to-noise (SNR), if there is
an amount of noise from crosstalk or reflections from imperfect termination will make the high-frequency noise will appear even larger and more detrimental in multi-level signaling (MLS) such as PAM-4. Nonetheless, the CTLE has been an effective equalization method in the receiver due to its capability of mitigating the precursors.

2.4.2 Decision feedback equalization

With the fundamental limitation of relative SNR degradation when the low frequency gain is reduced with CTLE, it could be combined with a type of discrete-time (DT) equalizer from which a quantized bit feed it back through FIR filtering. Noise amplification plagued in the linear equalizer no longer contaminate the bit decided by the digital filter. The decision feedback equalizer (DFE) uses ISI information about previously received data to subtract their ISI from the incoming bit. The channel loss will be compensated without the relative amplification of noise from crosstalk and reflections.

TX transmits data $x(n)$ over a channel with impulse response $h(n)$. At the receiver input,
\( y(n) = x(n) * h(n) \) contains ISI information about the transmitted bit \( x(n) \) from previously transmitted data. The receiver employs an N-tap DFE to cancel ISI from N postcursors. At the output of the DFE becomes

\[
y_d(n) = y(n) + \sum_{i=1}^{N} h_i \text{sgn}\{y_d(n-i)\}. \tag{2.13}
\]

A decision as to the polarity of the transmitted bit is made by feeding \( y_d(n) \) to the input of a slicer. Noting that \( \text{sgn}\{y_d(n)\} = x(n) \) for error-free operation, we can express \( y_d(n) \) as a function of the current bit \( x(n) \) as well as N previous bits.

\[
y_d(n) = y(n) + \sum_{i=1}^{N} h_i x(n-i) = \{x(n) * h(n)\} + \sum_{i=1}^{N} h_i x(n-i) \tag{2.14}
\]

In the z-domain, this can be expressed as,

\[
Y_D(z) = X(z) \left[ H(z) + \sum_{i=1}^{N} h_i z^{-i} \right] \tag{2.15}
\]

Considering a low-pass channel with transfer function

\[
H(z) = h(0) + h(1) z^{-1} + h(2) z^{-2} + \cdots = h(0) + \sum_{i=1}^{N} h_i z^{-i}, \tag{2.16}
\]

Postcursor ISI is cancelled if

\[
\sum_{i=1}^{N} h_i z^{-i} = - \sum_{i=1}^{N} h(i) z^{-i}. \tag{2.17}
\]

Hence,

\[
h_i = -h(i). \tag{2.18}
\]

The key constraint lies in the tight timing path. As seen in the Figure 2.8, a small analog input signal regenerate up rail-to-rail output through a slicer, feed it back through tap weighting, sum it, and then allow that to settle to sufficient precision within 1-UI such that,
$$t_{CLK-Q} + t_{h_1} + t_{setup} + t_{summer} < 1\text{UI}. \quad (2.19)$$

Figure 2.9: (a) Pulse response at 25-GSym/s, (b) Simulation result of eye-height with varying number of FIR taps [7].

Increasing I/O speed over highly lossy channels necessitate efficient approach to cancel long-tail post-cursor ISI. In the pulse response shown in Figure 2.9a indicates exponentially decaying RC-limited channel. Sufficient cancellation of post-cursor ISI requires a large number of FIR taps, as shown by Figure 2.9b, resulting in large power consumption. In order to meet the 1-UI timing constraint shown in (2.19) compact layout floorplan is critical in the DFE design. In order to address this, continuous-time tap can be incorporated beginning at the second post-cursor in a form of infinite-impulse response (IIR) filter by scaling time-constant. This approach allows several post-cursor ISI to be subtracted simultaneously with low power. A key challenge with this involves optimal search of both FIR and IIR tap settings.
2.5 PAM-4 transceiver design

An ability to deliver a wider range of termination voltage gives VM output driver an additional benefit that improves the linearity more importantly in PAM-4. As the impact of impedance mismatch on PAM-4 signal could be as high as 3x on NRZ signal, the high-swing output is preferred in the PAM-4 to preserve high SNR. In the design in [34], hybrid combination of VM and CM accommodates the output swing greater than its supply voltage without degrading linearity. Nonetheless, relatively low output swing in the wireline transmit drivers proves efficient as it did so in NRZ modulation for moderate loss short-reach (SR) applications from energy and linearity standpoints [35].

As the DFE in PAM-4 receiver generally assigns identical weights between slicers of 2-bit flash ADC in order to cancel post-cursor ISI from twelve different level transitions, the impact of non-linearity plays more significant role in PAM-4 than in NRZ [7]. As shown in Figure 2.10, timing skew between the most significant bit (MSB) and the least significant bit (LSB) causes static delay thus making clock and data recovery (CDR) at the receiver side more challenging. Gain mismatch will degrade nonlinearity with the eye height quantified by ratio of level mismatch (RLM) Bandwidth mismatch. Imbalanced output impedance imbalance can result in various slew
rates in twelve different transitions.

2.5.1 Transmitter

A common approach to designing extremely high-speed PAM-4 transmitters is to employ current-mode (CM) output driver for its superior immunity on the power supply noise [36, 35]. As depicted in Figure 2.11, weighted branch currents for MSB and LSB effectively sum onto termination resistors with feed-forward equalization (FFE) combined with ease. However, maximum swing level is challenged by the linearity constraint and power in the CM transmit drivers. Theoretical differential peak-to-peak voltage swing in the CM output driver is limited to,

$$V_{ppd,\text{max}} = \frac{2}{3} (AVDD - V_{OV})$$  \hspace{1cm} (2.20)

where the $V_{OV}$ is the overdrive voltage of MOSFET.
2.5.2 Receiver∗

Figure 2.12 shows the a dual-mode NRZ/PAM4 DFE receiver block diagram. In PAM4 mode symbol detection is achieved with a 2-bit flash ADC consisting of three comparators with threshold voltages of 0, ±2/3 relative to the post-equalized differential amplitude, while in NRZ mode all thresholds are set to zero. A quarter-rate architecture is employed to reduce clock buffer power and allow for longer comparator reset time, which minimizes hysteresis and allows smaller pre-charge transistor loading for improved evaluation delay. In order to minimize the critical first-tap feedback delay and maximize the equalization cancellation range, an FIR tap is utilized to cancel the first post-cursor ISI. This multi-level FIR tap is efficiently realized by feeding back the flash ADC 3-bit thermometer-coded output bits directly to three equally weighted summer inputs embedded in the comparatorsâ€™ first stage, removing any SR-latch and external summer delay from this critical path. Long-tail ISI is efficiently cancelled with 2 IIR taps, with one tap starting from the second post-cursor to cancel fast time constant ISI and the other beginning at the third post-cursor to mitigate the slow time constant ISI. In order to minimize the comparator’s internal loading, these IIR taps are subtracted from the sampled input with a current integration summer that precedes the comparators.

Figure 2.12: 1/4-rate FIR/IIR DFE PAM-4 Receiver.
3. AN 8-16Gb/s, 0.65-1.05pJ/b, VM TX WITH ANALOG IMPEDANCE MODULATION

FFE* 

3.1 Low-Power Transmitter Design Techniques

A typical low-power multi-channel serial-link transmitter architecture is shown in Fig. 3.1. In order to amortize clocking power, the output of a global clock generation circuit, such as a phase-locked loop (PLL), is distributed to all of the transmit channels. Here efficient global clock distribution techniques, such as low-swing CML signaling [17, 26], are often employed in high channel count systems which span several mm. Each transmit channel performs parallel data serialization, and implements equalization to compensate for frequency-dependent channel loss. This section reviews key low-power design techniques employed in this design, including capacitively driven wires for long-distance clock distribution [37] and impedance-modulation equalization [5].

Figure 3.1: Multi-channel serial-link transmitter architecture with dynamic power management.

* ©[2014] IEEE. Parts of this chapter are reprinted from "An 8-16 Gb/s, 0.65-1.05 pJ/b, Voltage-Mode Transmitter With Analog Impedance Modulation Equalization and Sub-3 ns Power-State Transitioning", by Young-Hoon Song, Hae-Woong Yang, Hao Li, Patrick Chiang, and Samuel Palermo, IEEE J. Solid-State Circuits., Nov 2014.
3.1.1 Global Clock Distribution

Distributing high-frequency clock signals over on-chip wires with multi-mm lengths is challenging due to wire RC parasitics that limit bandwidth, resulting in amplified input jitter and excessive power dissipation with repeated full-swing CMOS signaling [38]. As shown in Figure 3.2a, in order to reduce clocking power and avoid excessive jitter accumulation, low-swing non-repeated global clock distribution with an open-drain CML buffer driving on-die resistively terminated transmission lines has been previously implemented [17]. However, maintaining a minimum clock swing at high frequencies can still result in significant static power dissipation due to the transmission lines’ loss and relatively low-impedance. While reduction of this static power is possible with inductive termination of the distribution wire [26], this creates a narrow-band resonant structure that prohibits scaling the per-channel data rates over a wide range. Another non-repeated technique to drive long wires involves AC-coupling a full-swing CMOS driver to the distribution wire through a series capacitor, as shown in Figure 3.2b. Relative to simple DC-coupling, this technique allows for smaller drivers due to the reduced effective load capacitance, savings in signaling power due to the reduced voltage swing on the long-wire, and bandwidth extension due to the inherent high-frequency emphasis caused by the capacitive coupling [37].

![Figure 3.2: Low swing global clock distribution techniques: (a) CML buffer driving resistively terminated on-die transmission line; (b) CMOS buffer driving distribution wire through a series coupling capacitor.](image-url)
In order to compare the CML-based and capacitive-coupled low-swing clock distribution techniques, the global distribution circuitry of Fig. 3.2 are both designed for a 0.25 V low-frequency amplitude. The 65 nm CMOS simulation results of Figure 3.3 show that, relative to CML clock distribution with 50 Ω termination, this capacitively driven approach offers 1.7X bandwidth extension and 73.1% power savings when distributing a differential 4 GHz clock over a 2 mm distance. Also, the power of the capacitively driven approach reduces significantly at lower clock frequencies. This provides the potential for further power savings at a given data rate, provided that there is efficient multi-phase clock generation and low-to-high-swing conversion at the local transmit channels. Also, no major phase noise penalty is observed with the 0.25V capacitively driven distribution, as simulations with 4-GHz LC-oscillator driving the input buffer show that at the end of the distribution wire there is only a 0.1-dB degradation at a 1-MHz offset.

![Graphs showing output swing and power versus frequency for CML and capacitively driven clock distribution.](image)

Figure 3.3: Simulated comparison of CML and capacitively driven clock distribution over a 2 mm distance: (a) output swing versus frequency; (b) power versus frequency.

3.1.2 Voltage-Mode Transmit Equalization

While it is relatively easy to implement FIR equalizer structures at the transmitter by summing the outputs of parallel current-mode stages weighted by the filter tap coefficients onto the channel
and a parallel termination resistor \[17\], voltage-mode implementations are more difficult due to the series termination control. As shown in Figure 3.4, these voltage-mode topologies often set the equalizer taps’ weighting via output stage segmentation \([5, 3, 25, 4]\). One approach is to distribute the output segments among the main and post-cursor taps to form a voltage divider that produces the four signal levels necessary for a 2-tap FIR filter \[3\]. Here, all segments operate in parallel during a transition (or \(X[n] \neq X[n-1]\)) to yield the maximum signal level, while the post-cursor segments shunt to the supplies to produce the de-emphasis level for run lengths greater than one \((X[n] = X[n-1])\). As ideally all the segments have equal conductance, a constant channel match is achieved independent of the equalizer setting. However, shunting the post-cursor segments to the supplies results in dynamic current being drawn from the regulator powering the output stage and a significant increase in current consumption with higher levels of de-emphasis \[25\]. To address this, adding a shunt path in parallel with the channel can either eliminate dynamic current variations \[4\] or allow for a decrease in current consumption with higher levels of de-emphasis \[25\]. Further power reduction is possible if a constant channel match is sacrificed by implementing the different output levels via impedance modulation, allowing for minimum output stage current \[5\]. Here all segments are on during a transition to yield the maximum signal level, while for run lengths greater than one the post-cursor segments are tri-stated to generate a higher output resistance and produce the de-emphasis level.

![Figure 3.4: 2-tap FIR equalization in low-swing voltage-mode drivers.](image-url)
Figure 3.5: 10 Gb/s voltage-mode 2-tap FIR transmit equalization performance comparison. (a) Channel frequency responses. The three backplane channels have 5.2” total linecard traces and 12” (B12), and 20 bottom- (B20) and middle-layer (M20) backplane traces. The CPW channel is a single-board 5.8” FR4 trace and 0.6 m SMA cable. (b) Simulated 10 Gb/s pulse response with M20 BP trace. (c) Simulated 10 Gb/s pulse response with CPW channel. (d) Residual ISI, normalized to the main-cursor amplitude, with ideal 50 Ω and impedance-modulated output drivers. Error bars account for 15% RX termination mismatch.

As shown in the 10 Gb/s pulse response simulation results of Figure 3.5, the amount of residual...
ISI with a 2-tap equalizer depends on the equalization technique and channel type. In order to compare an impedance-modulated driver with an ideal 50-Ω driver, equal de-emphasis settings are utilized and the residual ISI is quantified by summing the absolute values of five pre-cursors and fifty post-cursors and normalizing by the main cursor value. For 20" backplane channels, an ideal 50 Ω driver displays similar residual ISI for middle- (M20) and bottom-trace (B20) channels with 13.1 dB and 11.7 dB de-emphasis, respectively. When an impedance-modulated driver is used, Figure 3.5b shows that reflections with the middle-trace channel (M20) degrade the residual ISI performance by 26.9% relative to the 50-Ω driver. However, this performance difference shrinks to only 12.8% for the bottom-trace channel (B20). With a shorter 12" bottom-trace channel (B12) that offers less overall ISI, but also less reflection attenuation, with 9.4 dB de-emphasis the residual ISI improves for both drivers and the relative ISI increase is less than 18.4% with the impedance-modulated driver. For the well-designed single-board co-planar waveguide (CPW) channel used in the Section V experimental results, which has performance comparable to channels proposed for high-density I/O systems [3], with 6.0 dB de-emphasis the ISI performance of the two drivers is almost identical. The impact of receive-side termination mismatch is also considered, with the error bars of Figure 3.5d showing that a ±15% mismatch of the ideal 100-Ω differential termination results in less than a 2% difference in the relative performance of the transmitters.

While impedance-modulated equalization may yield the best signaling current consumption, the output stage segmentation associated with this and other approaches can result in significant complexity and power consumption in the predriver logic. Overall, this predriver dynamic power, which increases with data rate and equalizer resolution, should be addressed in order to not diminish the benefits offered by a voltage-mode driver.
3.2 Multi-Channel Transmitter Architecture

Figure 3.6: 2-tap FIR equalization in low-swing voltage-mode drivers.

Fig. 3.6 shows a conceptual diagram of the proposed multi-channel transmitter architecture, with 10 transmitter channels spanning across a 2 mm distance. All transmitters share both a global regulator to set the nominal output swing, and two analog loops to set the driver output impedance.
during the maximum and de-emphasized levels of the implemented 2-tap FIR equalizer. Utilizing a single global regulator to provide a stable bias signal that is distributed to all the channels provides for independent fast power-state transitioning of each output driver, as explained in more detail in Section 3.3. The sharing of these global analog blocks allows for their power to be amortized by the channel number and improves the overall I/O energy efficiency.

In order to reduce dynamic power, low-swing clocks are maintained throughout the global distribution and local generation of the quarter-rate clocks used by the transmitters. Rather than distributing four quarter-rate clocks globally, which offers challenges in maintaining low static phase errors and power consumption, a differential quarter-rate clock is distributed globally in a repeater-less manner via capacitively driven low-swing wires [37]. A voltage swing of

$$V_{\text{swing}} = \frac{C_s}{C_s + C_w} \text{VDD}$$  \hspace{1cm} (3.1)

is present on the long global distribution wires from the voltage divider formed by the series coupling capacitor, $C_s$, and the clock wire capacitance, $C_w$. The value is set for a swing of Vdd/4, which is 250 mV for the 4-GHz clocks used in 16-Gb/s operation with a 1V supply. These low-swing distributed clocks are then buffered on a local basis by AC-coupled inverters with resistive feedback for injection into a two-stage injection-locked oscillator (ILO) which produces four full-swing quadrature clocks that are shared by a two-channel bundle. Utilizing a Vdd/4 distribution swing allows the ILO to achieve a locking range greater than 250-MHz, which ensures locking over 5% power supply variations. Simulation results show that the clock swing degrades by only 1% at the end of the 2 mm distribution wire. As transmit architectures which utilize quarter-rate clocks for serialization are sensitive to timing offsets amongst the four clock phases, particularly with the aggressive supply scaling employed in this low-power design, digitally calibrated buffers controlled by an automatic phase calibration (PC) loop produce the final clocks that control the data serialization.
Fig. 3.7 shows the two-stage ILO schematic, where quadrature output phase spacing is improved by AC-coupling the injection clocks, adding dummy injection buffers, and optimizing the locking range via digital control of the injection buffers’ drive strength. The ILO employs cross-coupled inverter delay cells which, relative to current-starved delay cell-cells [16], generate a rail-to-rail output swing with better phase spacing over a wide frequency range. Coarse frequency control is achieved via a dedicated power supply equal to DVDD, but separated on-chip for noise isolation. The gated analog voltage, EN_VCTL, finely controls the ILO frequency by setting the delay cell pull-down strength. While not implemented in this prototype, a periodically activated control loop could set EN_VCTL such that the ILO free-running frequency is equal to the injection clock [39] to reduce quadrature phase errors and provide increased robustness to PVT variations. This analog control voltage can also be rapidly switched between GND and its nominal value, enabling fast power-up/shut-down of the clock signals on a two-channel resolution.
3.3 Transmitter Channel Design

A block diagram of a transmitter channel is shown in Fig. 3.8. The transmitter exhibits two operating modes to provide transmitter equalization at higher data rates, while dramatically scaling energy efficiency at lower data rates by reducing the digital serialization and pre-driver supply (DVDD) and disabling equalization when it is not required. While an external supply is used to set the scalable DVDD in this prototype, an adaptive switching regulator [18] could efficiently generate this supply. Eight bits of parallel input data are serialized with an initial 8:4 multiplexer followed by two parallel 4:1 stages that produce the main and post-cursor tap signals for the 2-tap
equalizer implemented in the differential low-swing impedance-modulated voltage-mode driver. The serialized data passes through level-shifting pre-drivers [16] that boost the voltage swing by a full scalable supply value, DVDD, above the nominal nMOS threshold voltage, enabling reduced output stage transistor sizing for given impedance value. Power is saved by disabling the post-cursor tap pre-driver at lower data rates where equalization is not required. The clocks which synchronize the serialization are produced by passing the ILO quadrature outputs through buffers with duty-cycle and quadrature spacing correction via 5 bits of p-n strength and 5 bits of delay capacitance adjustment, respectively. Two of these phases are divided by two to perform the initial 8:4 multiplexing, while all four phases pass through conventional CMOS logic to generate the pulse-clock signals that switch the secondary 4:1 CMOS muxes.

3.3.1 Automatic Quadrature-Phase Calibration

While a transmitter architecture which utilizes quarter-rate clocks for serialization allows for reduced supply voltages in the data path, this low-voltage operation results in increased phase-spacing variations amongst the critical serialization clock signals [16]. The resultant output deterministic jitter from static phase errors and duty cycle distortion of the quadrature clocks can severely degrade eye height and timing margins for data rates well in excess of 10 Gb/s. This design addresses this important issue and enables high-speed operation at low supply voltages by implementing the closed-loop calibration scheme detailed in Fig. 3.8. In calibration mode, the transmitter output for two complementary fixed patterns is sampled with a comparator clocked by an asynchronous 100 MHz signal. The uniformly spaced output samples obtained by employing this asynchronous clock provide information about the duty cycle and quadrature phase spacing errors [40, 41]. First, the duty cycle is corrected by comparing the count value obtained for a $\bar{A}I\bar{J}1100\bar{A}I$ output pattern and its complement, followed by an FSM that adjusts the p-n strength of the local clock buffers. Second, quadrature phase correction is realized by utilizing a $\bar{A}I\bar{J}1010\bar{A}I$ pattern and its complement, with the FSM then adjusting the relative delay of the buffers through capacitive tuning.
3.3.2 Impedance-Modulated Output Driver

Figure 3.9 shows the low-swing all-nMOS output stage, where a new impedance modulation technique [5] is introduced. In addition to the M1 switch transistors controlled by the main-cursor data, extra transistors M3-5 are stacked to achieve 2-tap impedance-modulated equalization. Analog control of the stacked transistor impedance values provides the potential for high-resolution equalization tap control with a non-segmented output stage, dramatically reducing pre-driver complexity and resulting in significant power savings. During a transition bit in equalization mode (Figure 3.9a) the maximum output swing is achieved with nearly a 50 output impedance, when both the higher-impedance single-transistor M3 and lower-impedance two-transistor paths (M4 and M5) controlled by the post-cursor data are activated in parallel.

\[ R_{\text{tran\_bit}} = (R_{M4} + R_{M5}) \parallel (R_{M3} + R_{M1}) = Z_o \]  

(3.2)

where is the characteristic channel impedance (50-Ω). The sizing overhead of this effective three-transistor stack is minimized because the switch transistors controlled by the main and post-cursor data see a large level-shifted overdrive voltage, \( V_{\text{LVS}} = V_{\text{DD}} + V_{\text{THN}} \), when turned on. Only the higher-impedance single-transistor M3 pull-up/pull-down path is activated for run-lengths greater than one (Figure 3.9b), with the de-emphasis level set by the analog control voltages, \( V_{\text{ZmeqUP}} \) and \( V_{\text{ZmeqDN}} \), provided by the global de-emphasis impedance modulation loop.

\[ R_{\text{de\_emp}} = R_{M3} + R_{M1} = \frac{(1 + 2\alpha)}{(1 - 2\alpha)} Z_o \]  

(3.3)

where \( \alpha \) is the equalization coefficient (Figure 3.4) and the peaking ratio between the maximum and minimum output signal levels is

\[ \frac{V_{\text{ppd,max}}}{V_{\text{ppd,min}}} = \frac{1}{1 - 2\alpha}. \]  

(3.4)

In non-equalization mode, the output stage is placed in a standard configuration with a single
Figure 3.9: Output driver with impedance-modulated 2-tap equalizer: (a) transition-bit state; (b) de-emphasis state.
series impedance-control transistor M2 in the pull-up/pull-down paths, where the control voltages, \( V_{zcUP} \) and \( V_{zcDN} \), are provided by the global impedance control loop. Furthermore, the post-cursor pre-drivers are disabled to save power.

### 3.3.3 Global Impedance Control and Modulation Loop

The global replica-bias loops that produce the impedance control bias voltages for the 2-tap transmitter output stages are shown in Figure 3.10. A 50-\( \Omega \) channel match is obtained with the left circuit that contains two feedback loops which force a value of \((3/4)V_{REF}\) and \((1/4)V_{REF}\) on the positive and negative outputs, respectively, of a replica transmitter loaded by a precision off-chip 100-\( \Omega \) resistor. Configuring the circuit in non-equalization mode places the stacked M2 impedance control transistors in the feedback loops to produce the \( V_{zcUP} \) and \( V_{zcDN} \) control voltages that bias the M2 transistors of the output stages. In equalization mode, the stacked parallel M3 and M4-5 paths are placed in the feedback loops to produce the \( V_{zceqUP} \) and \( V_{zceqDN} \) control voltages that bias the output stages’ M4 transistors to achieve a 50-\( \Omega \) match during a transition bit.

De-emphasis-level reference voltages \((3/4)V_{REF}-(1/2)\alpha V_{REF}\) and \((1/4)V_{REF}+(1/2)\alpha V_{REF}\) are used in the right circuit to produce the M3 bias voltages, \( V_{zmeqUP} \) and \( V_{zmeqDN} \), for the high resistance values used when the data run-length is greater than one. For all settings the M1 and M5 replica switch transistors bias is generated by a diode-connected nMOS whose source is connected to the scalable DVDD, producing a voltage level, \( V_{LS} = V_{thn} + DVDD \), consistent with the level shifting pre-driver output.

High-resolution equalization settings are possible with low power overhead via a low-frequency global DAC to set the de-emphasis voltage levels used in the replica bias loop. This compares favorably with achieving tap value control via a highly segmented output stage, which requires complex pre-driver circuitry switching at the full data rate [5, 3, 25, 4]. While there is some power overhead associated with the global analog feedback loops, power amortization in a multi-channel system minimizes the impact on the overall transmitter energy efficiency.
Figure 3.10: Global replica-bias loops for output driver impedance and de-emphasis control.
3.4 Experimental Results

Figure 3.11 shows a die microphotograph of the proposed transmitter, fabricated in a general purpose 65 nm CMOS process. While chip area constraints prevented a full 10-channel prototype,
the concept is accurately emulated by placing a two-transmitter bundle at the end of a snaked on-chip 2 mm clock distribution. Each transmitter channel occupies 0.006 mm, and the combined area of the injection-locked oscillator, global impedance control and modulation loop, bias circuitry, and global regulator is 0.014 mm. ESD diodes with 40 fF parasitic capacitance are present at the high-speed transmitter outputs.

Figure 3.12: FR4 channel eye diagrams without and with automatic phase calibration at (a) 8 Gb/s and (b) 16 Gb/s

The functionality of the automatic phase calibration is demonstrated with a chip-on-board test setup, with the die directly wirebonded to the FR4 board and the transmitters driving short 2 traces. Lower data rates display worse inherent phase spacing performance due to the reduced voltage operation, with Figure 3.12 showing a 28.5% uncorrected eye width variation at 8 Gb/s and a 0.75 V supply. These phase errors are reduced to 4.7% when the closed-loop phase calibration is enabled.
TXV\textsubscript{max} = 300 mV\textsubscript{ppd} with 3, 6, 9, and 12 dB EQ

Figure 3.13: (a) Measured equalization impedance versus de-emphasis amount with a 300 mV\textsubscript{ppd} output swing. (b) Low-frequency transmitter output waveforms with 3-12 dB de-emphasis.

At 16 Gb/s and 1 V operation, the phase calibration loop improves the eye width variation from an uncorrected 13.1\% to 5.4\%, limited by nonlinearities in the duty-cycle tuning range. Note that while a 1 V DVDD is required for 16-Gb/s operation, transient simulations indicate that the level-
shifted pre-drive signals generate a maximum and which does not exceed 1.1 V in the switched output stage transistors due to the stacked design. These voltage levels are below the 10-year lifetime requirements.

A channel consisting of a 5.8" FR4 trace and a 0.6 m SMA cable (Figure 3.5a), with 15.5-dB loss at 8-GHz, is used to characterize the transmitter’s equalization capabilities. Figure 3.13 shows that the global impedance modulation loop precisely controls the required impedance for a given equalization coefficient to within 7% of the ideal value, while low-frequency output patterns with a peak 300mV output swing verify the equalizer’s functionality up to the maximum 12 dB setting. The transmitter transient performance at a maximum 16-Gb/s data rate is verified with the $2^7 - 1$ PRBS eye diagrams shown in Figure 3.14, where a previously near-closed eye is opened to a 55 mV height and 33.4 ps width when the impedance-modulation equalization is enabled.

In order to demonstrate the transmitter’s scalable energy efficiency over data rate, the eye diagrams of Figure 3.15 are produced with the same channel as Fig. 16 and with a minimum 50 mV eye height and $\sim$0.5UI eye width. From these eye diagrams, the total jitter can be decomposed into deterministic and random components of 31.6 ps and 2.27 ps\textsubscript{rms}, respectively, at 8-Gb/s, and 25.2 ps and 1.19 ps\textsubscript{rms} at 12-Gb/s. For this performance level the transmitter achieves 8-16 Gb/s operation at 0.65-1.05 pJ/b (Figure 3.16a) by optimizing the transmitter’s scalable supply and out-
Figure 3.15: Transmitter eye diagrams and jitter decomposition at (a) 8 Gb/s and (b) 12 Gb/s.

put swing and disabling equalization at the lowest 8-Gb/s data rate. While the dynamic clocking and serialization power dominates, as shown in the power versus data rate of Figure 3.16b and the detailed-16 Gb/s power breakdown of Table 3.1, scaling the digital supply reduces this contribution and allows for overall improved energy efficiency at lower data rates.

Table 3.2 compares this work with recent voltage-mode transmitters with 2-tap equalization. The low-voltage architecture allows for a dramatic increase in data rate at near 1 pJ/b energy efficiency, which is only achieved at 10 Gb/s in [25], while the impedance-modulated equalization is capable of obtaining open eyes over the highest loss channel. Moreover, as indicated by the 16 Gb/s power breakdown in Table 3.1, further improvements in energy efficiency are possible through increased amortization with a higher channel count and by scaling the design to a more
Figure 3.16: Measured transmitter performance versus data rate: (a) energy efficiency; (b) power breakdown.
### Table 3.1: Transmitter Power Breakdown at 16-Gb/s

<table>
<thead>
<tr>
<th>Component</th>
<th>Power (μW)</th>
</tr>
</thead>
<tbody>
<tr>
<td>Global Regulator (amortized across 2 TX) &amp; Output Driver (300mV&lt;sub&gt;ppd&lt;/sub&gt; with EQ)</td>
<td>985</td>
</tr>
<tr>
<td>Serializer, Pre-drivers, Clocking</td>
<td>10.8</td>
</tr>
<tr>
<td>Global Impedance Control &amp; Modulation Loop, Bias Circuit</td>
<td>1.1</td>
</tr>
<tr>
<td>(amortized across 2 TX)</td>
<td></td>
</tr>
<tr>
<td>Global Clocking (amortized across 2 TX)</td>
<td>1.5</td>
</tr>
<tr>
<td>ILO (amortized across 2 TX)</td>
<td>2.4</td>
</tr>
<tr>
<td><strong>Total Energy Efficiency</strong></td>
<td><strong>1.05pJ/b</strong></td>
</tr>
</tbody>
</table>

advanced CMOS process that allows for reduced dynamic power.

### 3.5 Chapter Summary

A low-power, scalable, high-speed transmitter architecture is presented. In order to reduce clocking power, low-swing clocks are maintained throughout the capacitively driven low-swing global distribution and local ILO quadrature phase generation. Improved dynamic power consumption is achieved with aggressive supply scaling at lower data rates, while automatic quadrature phase calibration allows for uniform output eyes at low voltages. By realizing a 2-tap equalizer with analog-controlled impedance modulation, output stage current is reduced and driver segmentation is obviated, allowing for reduced pre-driver complexity and further dynamic power savings. Employing a global regulator that provides a replica-bias voltage to the transmit channels,
Table 3.2: Transmitter Performance Comparisons

<table>
<thead>
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<th></th>
<th>[7]</th>
<th>[8]</th>
<th>[9]</th>
<th>This Work</th>
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<tr>
<td><strong>Technology</strong></td>
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<td>45nm</td>
<td>90nm</td>
<td>65nm</td>
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<tr>
<td><strong>Supply Voltage</strong></td>
<td>1.2V</td>
<td>1.08V &amp; 0.93V</td>
<td>1.15V</td>
<td>0.75 &amp; 0.5V</td>
</tr>
<tr>
<td><strong>Data Rate</strong></td>
<td>10Gb/s</td>
<td>7.4Gb/s</td>
<td>4Gb/s</td>
<td>8Gb/s</td>
</tr>
<tr>
<td><strong>TX Swing</strong></td>
<td>160mV~500mVppd</td>
<td>800mVppd</td>
<td>0-1Vppd</td>
<td>100mV~300mVppd</td>
</tr>
<tr>
<td><strong>Channel Loss At Nyqu Freq</strong></td>
<td>-13dB</td>
<td>Not Reported</td>
<td>-8 to -10dB</td>
<td>-15.5dB</td>
</tr>
<tr>
<td><strong>Equalization</strong></td>
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<td>2-Tap FIR</td>
<td>2-Tap FIR</td>
<td>None</td>
</tr>
<tr>
<td><strong>Power</strong></td>
<td>10mW</td>
<td>32mW</td>
<td>8mW</td>
<td>5.2mW</td>
</tr>
<tr>
<td><strong>Energy Efficiency</strong></td>
<td>1pJ/b</td>
<td>4.32pJ/b</td>
<td>2pJ/b</td>
<td>0.65pJ/b</td>
</tr>
</tbody>
</table>

along with staggered switching of the output stage decoupling capacitance, allows for rapid enabling/disabling of the output drivers on a per-channel basis. Leveraging the proposed transmitter design can allow for low-power operation with the capabilities to efficiently support equalization for high-data-rate operation and scalable supply voltage management.
Nonlinear driver impedance mapping of highly segmented output stage in aforementioned VM drivers requires complex pre-driver circuitry switching at the full data-rate, thus resulting in significant parasitic at the output nodes and dynamic power consumption. In [29], analog impedance control loops provide high-granularity 2-tap FFE weight control which allows elimination of digital segmentation and amortization of static power induced by the impedance control loops in high-density channel I/O, dramatically mitigating pre-driver complexity and dynamic power. Our work in this transaction is improved upon the low-swing VM transmit equalizer with impedance control which obviated output stage segmentation. However, our work differs from [29] as follows: 1) A pulse-selected multiplexing technique in the output stage allows higher bandwidth with reduced parasitic capacitance and resulting deterministic jitter (DJ), 2) Incorporation of 2-tap FFE which necessitated 3-stack NMOS transistors in the past work is realized with 2-stack NMOS transistors reducing additional dynamic power, 3) PAM-4 modulation is readily realized by exploiting 4-level 1-tap FFE used in NRZ coding.

4.1 System Architecture

Shown in Fig. 4.1 is an overall transmitter architecture of the proposed dual-mode NRZ/PAM-4 two channel transmitter. The NRZ performance is configurable with the need for impedance match to the characteristic impedance of channels in high-performance (HP) mode or for signaling efficiency in energy-efficient (EE) mode by disabling some of building blocks as indicated by grey lines. Two or potentially higher density of TX channels share a global voltage regulator and impedance control loops for saving per-lane TX power. For the 1/4-rate operation of the transmitter, a 1/2-rate externally differential clock is divided by two to produce the 1/4-rate quadrature clocks followed by CMOS buffers with duty-cycle correction (DCC) and quadrature error correc-

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Sixteen bits of low speed parallel $2^{15} - 1$ pseudo-random bit sequence (PRBS) input data are serialized by 16:8 multiplexer followed by a path-selector which directs the initially serialized data to either NRZ or PAM-4 data path. An optimal choice of sampling phase at each serializer stage is essential to perform a wide range of data-rates. For NRZ operation, initially multiplexed 8b data pass through a latch-based 8:4 multiplexer stage followed by four parallel intermediate serialization stage to where current and 1-UI delayed bits are returned in a recursive sequence with relaxed timing margin and power. On the other hand, PAM-4 data are split by 4b LSB and MSB portions after gray-coding for simultaneous inputs of intermediate serializer stage. In order to collaborate with output driver slices in the output multiplexing (OM) structure, the intermediate serialization stage is segmented by four slices for parallelism. Each slice in the intermediate serializer shown in Fig. 4.1 includes retiming flip-flops, data multiplexers, encoder logic, predrivers, and pulser with propagation delays $t_{clk-q}$, $t_{mux}$, $t_{encode}$, and $t_{pulse}$, respectively. The proposed low-swing differential VM transmit driver featuring 4:1 output multiplexing obivates the nonlinear driver impedance mapping of highly segmented output stage.

And replica-bias impedance control loops provide control of path impedance in the output
Figure 4.2: Static timing analysis in the serializer circuit over scalable supply voltage: (a) Timing diagram for data and clock path; (b) Propagation delays of digital logic circuits over scalable supply; (c) Maximum data rate vs. phase selection.

driver that sets either the de-emphasis level in NRZ mode or the middle symbol levels in PAM-4 mode. The background analog control allows to track environmental changes and PVT variations [29]. The transmitter provides configurable performance in NRZ modulation. In the high-performance (HP) controlled-impedance setting, the output impedance of the transmit driver is
matched to the nominal characteristic impedance of the channel on any data pattern thus absorbs
signal echo reflected at the receiver by allowing extra current drawn to the output driver [30].
Significant power can be saved in the energy-efficient (EE) impedance-modulated setting with sig-
nering efficiency in the transmit driver and disabling some of building blocks at the expanse of
output termination [31, 29].

\[ t_{clk-q} + t_{mux} + t_{encoder} + 1 \cdot UI < n \cdot UI + t_{d,pulse} + t_{skew} \]  \hspace{1cm} (4.1)

\[ t_{d,pulse} + t_{skew} + (n + 1) \cdot UI < t_{clk-q} + t_{mux} + t_{encoder} + 4 \cdot UI \]  \hspace{1cm} (4.2)

\[ \frac{n - 3}{[t_{clk-q} + t_{mux} + t_{encoder} - t_{skew}]_{Supply@750mV}} < f_o < \frac{n - 1}{[t_{clk-q} + t_{mux} + t_{encoder} - t_{skew}]_{Supply@1.05V}} \]  \hspace{1cm} (4.3)

4.2 Static Timing Analysis on the Critical Timing Path

The retiming flip-flops generate the necessary 1-UI delay for the 2-tap FFE in NRZ mode by
returning data in a recursive sequence with relaxed timing margin and power consumption while
in PAM-4 mode the parallel 8b input is retimed into two 4b MSB and 4b LSB paths with a same
clock. The data is propagated through combinational logic to be translated into switching signals
upon different configurations (HP or EE setting) before being captured by the time-interleaved
pulse clocks in the level-shifted pre-drivers.

The objective of STA is to make an optimal choice of sampling phase at the serialize stage to
operate over a wide range of data rates by defining minimum and maximum possible data rates [42].
The allowable data-rates are restricted by contamination delays introduced by the combination of
main and post 1-UI data in NRZ as shown in Fig. 4.2b. The lowest and the highest data rates are
determined by the \( T_A \) and \( T_B \) as shown by (4.1) and (4.2), respectively.

The entire serialization chain operates on a scalable supply that allows for reduced power con-
Figure 4.3: Simplified circuit diagrams of VM transmit driver: (a) Input multiplexing; (b) Output multiplexing.
sumption at lower data rates. Propagation delays over the scalable supply are obtained from post-layout simulation as shown in Fig. 4.2c. The allowable data-rate with this process node used in this work is shown in Fig. 4.2d. For $n = 3$, up to 20Gb/s NRZ operation is achievable. For $n > 3$, however, the maximum data rates are limited below what is achievable mathematically with clock bandwidth.

4.3 Differential 4:1 Output-Multiplexing Transmit Driver

Major advantage of output multiplexing stems from saving dynamic power consumption achievable through relaxed switching speed due to time-interleaved parallel switching in the pre-driver stage which allows reduction of supply voltage [18, 16]. The output multiplexing can also benefit from elimination of deterministic jitter (DJ). Conceptual illustrations of the input and output multiplexing circuits and timing diagrams are shown in Fig. 4.3. For clarity, only one polarity of differential inputs is shown. An equivalent RC models are defined to perform an analysis at the critical node. In addition to the time-constant formed by on-resistance of a transfer gate and turn-on capacitance ($C_{TG, on}$), each of three turn-off transfer gates contribute junction capacitance ($2C_{eff}W$) to larger time-constant ($\tau_{inputmux}$) in the input multiplexing and thus lower edge rate as depicted in Fig. 4.3a. This results in significant ISI at the pre-driver input. Although, data edge will be sharpened by the following inverter-based pre-driver which has a fan-out of $f$, the degraded DJ remains up to the output. Assuming same resistance as transfer gate’s on-resistance, the time-interleaved NAND gates pre-charged by low-speed data in the output multiplexing allow independent capturing of data by a pulse clock with relaxed timing-margin. And only one switch segment is activated at each pulse-clock without being affected by prior and successive bit values as illustrated in the Fig. 4.3b. The reduction of self-capacitance at internal nodes by separating predriver segments for different phases improves the edge rate thus effectively extends the bandwidth of output stage and improves the DJ. Additionally, this NAND gate does not require complementary pulse clocks and power to generate them. Without the time-matching requirement of the differential pulse clocks, the output multiplexing will further improve jitter performance and ease the DCC and QEC algorithm.
Figure 4.4: Transmitter eye diagrams and jitter decomposition at (a) 8 Gb/s and (b) 12 Gb/s.
Figure 4.5: Transmit driver for transitioning and de-emphasized bit state with associated impedance paths in (a) High-performance (HP) Mode (for both NRZ and PAM-4) and (b) Energy-efficient (EE) mode (for NRZ only).

One of the challenges associated with scalable-supply operation with voltage-mode output drivers involves maintaining proper match to the characteristic impedance of channel with reduced supply for low power without size overhead of switch NMOS in the output driver. The level-shifting pre-driver stage is proven effective by producing pulse-sampled data boosted up to
scalable $\text{DVDD} + V_{\text{thn}}$ when turned on such that size of the switch NMOS transistor can become smaller [18, 16, 29]. In order to incorporate 2-tap FFE in the transmit driver, however, the size overhead imposed by the 3-stack NMOS transistors, two switch NMOS transistors and one impedance controlled NMOS in series as shown in Figure 4.4a, on the low-impedance path put constraints on the edge rate and power efficiency due to the large loading capacitance driven by the pre-driver stage [29]. Introducing an encoder logic to provide performance scalability in this work, a transmit driver with 2-NMOS stack is proposed allowing for dramatic size reduction of switch NMOS transistors, thus higher bandwidth and dynamic power saving. In order to allow the serialization and predriver logic to operate at the reduced supply voltage, the final 4:1 serialization is performed in the output multiplexing driver of Fig. 4.5. This driver consists of three parallel segments with all NMOS transistors. Each segment has single top/bottom analog-controlled transistors, which control the output impedance and set either the de-emphasis level in NRZ mode or the middle symbol levels in PAM-4 mode, and four parallel slices of middle digitally-switched transistors that perform the output multiplexing.

4.3.1 High-Performance NRZ mode

In many practical wireline I/O transmitters, equalization techniques are used to compensate for bandwidth-limited channels by linearly pre-distorting transmit signal to compensate for ISI. However, the controlled impedance for termination is of critical concern. Insertion loss deviation (ILD) due to reflections can become more serious than frequency-dependent loss as the reflection becomes another major source of ISI. For consistent electrical performance in the digital I/O link where the variation tolerance of TX output impedance is low (e.g. legacy backplane, low-cost connector, and multi-drop bus (MDB)), the transmit equalizer can be configured to high-performance (HP) controlled-impedance setting with power penalty. Fig. 4.5a shows the VM differential 4:1 output multiplexing transmit driver circuitry and signal paths for the HP setting. The low-swing VM driver is comprised of 2-stack pull-up/pull-down NMOS transistors. The NMOS switches (M1-M3) in each slice are driven by level-shifted pre-driver outputs to close signal paths for differential full/de-emphasized swing outputs. Similarly, LSB and MSB data encoded in the logic
slices that drive M1-M3 with pre-drivers to form signal paths for full/mid-level PAM-4 symbols.

In addition to the M1-M3 switch transistors, other NMOS transistors M6-M8 are stacked to control impedance of highlighted branches for 2-tap FFE in NRZ mode or middle symbol generation in PAM-4 mode with the gate voltages V_{XX}{HP}, V_{XX}{HF}, and V_{XX}{HP_d} produced by the AICLs that emulates corresponding signal paths.

For a transitioning bit in the HP setting in NRZ and a gray-coded symbol 2b’00 or 2b’10 in PAM-4, the maximum output swing is generated by closing the lower impedance (M1 and M6) and higher impedance (M2 and M7) paths as highlighted in red dash-dot line. In the parallel combination of these paths the output impedance is terminated to the characteristic impedance of channel such that

\[(R_{M1} + R_{M6})|| (R_{M2} + R_{M7}) = \frac{Z_O}{1 - \alpha} \parallel \frac{Z_O}{\alpha} = Z_O\]  \hspace{1cm} (4.4)

where \(Z_O\) and \(\alpha\) are the characteristic channel impedance and the peaking ratio between full and de-emphasized output voltage swings, respectively. De-emphasized output swing is produced by creating a voltage divider path from VREF to GND. In order to prevent glitches when full-swing bits turn to de-emphasized level for data run-length greater than one in NRZ, only the high-impedance path (M2 and M7) is de-activated. And another path (M3 and M8) is activated while the low-impedance path (M1 and M6) remains closed as indicated by blue dash line such that,

\[(R_{M1} + R_{M6})|| (R_{M3} + R_{M8}) = \frac{Z_O}{1 - \alpha} \parallel \frac{Z_O}{\alpha} = Z_O.\]  \hspace{1cm} (4.5)

As seen in (4.4) and (4.5), it is worth noting that a controlled channel match is achieved during both transitioning and run-length greater than one. Similarly, for PAM-4 operation, the gray-coded symbols 2b’01 and 2b’11, the mid-level output voltage where the \(\alpha\) is set to 0.33, is produced with low output impedance allowing fast transitions to mid-level symbols thanks to a low time-constant.

For full-swing transition the output current drawn from the voltage regulator powering is

\[I_{full, HP} = \frac{V_{REF}}{4Z_O}.\]  \hspace{1cm} (4.6)
Table 4.1: A boolean function logic of switching signals in the dual-mode NRZ/PAM-4 transmit driver

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Dynamic power is greatly reduced on consecutive 0/1s

And, the current drawn for de-emphasized NRZ swing and middle symbol level output during the HP setting is

$$I_{de-em,HP} = \frac{V_{REF}}{Z_O} \left[ \frac{1}{2} - \left( \frac{V_{de-emp}}{V_{REF}} \right)^2 \right]$$

(4.7)

where the $V_{REF}$ is the differential peak-to-peak output voltage swing level and $V_{de-emp}$, the de-emphasized voltage level.

4.3.2 Energy-Efficient NRZ mode

A major disadvantage with the HP setting, however, is its signaling inefficiency involving in generating lower de-emphasized output swing as shown in (4.7). For signaling efficiency, it is desirable that lower current is drawn from the voltage regulator output for de-emphasized swing when
the transmit driver is generating long stream of 0s/1s. Among a few low-swing VM output drivers, impedance modulating transmit driver introduced in [31] yields increased output impedance so as to produce de-emphasized output such that induced current scales linearly with output voltage swing for signaling efficiency. As the TX output impedance becomes greater than $Z_O$ for de-emphasis, however, reflections from the RX end will not be absorbed at the TX output resulting in uncompensated ISI. Some studies have found that impedance discontinuity is unavoidable due to the package parasitic capacitance, bonding inductance and process variation in the transmitter output stage. Given a good termination at the receiver side, however, the impact of impedance discontinuities becomes less significant over longer channels, because the resulting reflections must experience higher attenuation before bouncing at the transmitter output [31, 29].

Fig. 4.5b shows transmit driver circuitry with signaling paths configured to energy-efficient (EE) impedance-modulated setting for signaling efficiency. For impedance control on the associated paths gate voltages, $V_{XXEE_F}$ and $V_{XXEE_D}$ on M5 and M9, respectively, are generated by impedance control loop for both maximum and de-emphasized output swings. During a transitioning bit period in EE setting, the maximum output swing is achieved with $Z_O$ output impedance, when higher impedance M3-M9 and lower impedance M1-M5 paths are activated in parallel as shown by blue dash line such that

$$
(R_{M1} + R_{M5})||(R_{M3} + R_{M9})
= \left( \frac{1}{2} + \frac{1}{4\alpha} \right) Z_O \frac{1 + 2\alpha}{1 - 2\alpha} Z_O = Z_O f
\tag{4.8}
$$

By increasing the output impedance of the transmit driver for run-length greater than one, only the higher impedance (M3-M9) path remains closed to produce de-emphasized output swing as indicated by red dash-dot line, thus modulated output impedance is

$$
R_{M3} + R_{M9} = \frac{1 + 2\alpha}{1 - 2\alpha} Z_O
\tag{4.9}
$$
Figure 4.6: Global replica-bias loops for output driver impedance and level control: (a) de-emphasis and PAM-4 opposite polarity path control in HP setting (disabled in EE setting); (b) de-emphasis primary polarity path control; (c) full-swing impedance control; (d) Mismatch-free IDAC circuitry used in (a).

The current drawn from the voltage regulator output in EE setting is formulated as follows:

\[ I_{de-emp,EE} = \frac{V_{REF}}{4Z_O} (1 - 2\alpha) \]  

(4.10)

whereas the current drawn for full-swing in EE mode is same as the one in HP mode shown by (4.6). From (4.10), the signaling current is reduced linearly with de-emphasis level.

Additionally, dynamic power from the pre-driver is significantly reduced in EE setting by disabling all pre-drivers that drive low impedance path for run-length greater than one. With the predriver stage directly toggled by data \( X[n] \) (or \( X[n - 1] \)) in the 3-stack NMOS transmit equalizer used in [29], pre-drivers associated with \( X[n - 1] \) (or \( \overline{X[n - 1]} \)) should wastefully drive large
M2tn and M2bn while the entire 3-stack low impedance path should be disabled by $\overline{X[n]}$ (or $X[n]$) as shown in Fig. 4.4a. In the proposed transmit driver where the pre-drivers producing encoded data $Y[n]$, $Y_D[n]$, and $Y_F[n]$ for 2-stack NMOS transistors, however, only pre-drivers that drive relevant NMOS transistors in long stream of 0s/1s are activated, cutting down the number of power-consuming transition occurrences of pre-drivers, i.e. effectively reduce the activity factor, $a$ shown in (2.1). Table. 4.1 summarizes the boolean function table of encoder logic.

4.4 Impedance Control Loops

Impedance Control Loops running in the background can continuously track variation in device parameters due to environmental changes such as temperature. In order to provide transmit driver with proper NMOS biasing voltages that controls de-emphasized swing level for NRZ and middle level PAM-4 modulation, replica-based impedance control loops are implemented as shown in Fig.4.6. Only two high-precision SMD resistors are used to emulate receiver-side termination. By
applying desired reference voltages of the de-emphasized output swings of NRZ or PAM-4 middle levels to the replica circuits (a) and (b), nodes that emulate positive and negative polarities of output are forced to be the reference voltages such that output driver’s NMOS gate-biasing voltages are generated through negative feedback loops. The impedance controlled NMOS transistors in the two channel transmit drivers are driven by a set of inverters powered by supply voltages generated by the impedance control loops, thus eliminating interaction between different loops [26, 29]. For all settings, replica switch transistors bias is generated by a diode-connected NMOS transistor whose source is connected to the scalable DVDD, producing a voltage level, \( V_{LS} = DVDD + V_{thn} \), consistent with the level shifting pre-driver output as shown in Fig. 4.6a. In the EE setting, nodes at \( V_{UP HP_D} \) and \( V_{DN HP_D} \) are tied to GND to disable the impedance path, and the control loop circuitries in (a) including error amplifiers and IDAC are completely disabled reducing considerable amount of power. In Fig. 4.6b, gate control voltages \( V_{UP HP_D} \) and \( V_{DN HP_D} \) for impedance control of primary polarity path are obtained by a pair of error amplifiers (B and C) enabled for HP mode only. During the HP mode, a constant channel match is achieved independent of the data pattern. In EE setting, another pair of error amplifiers (A and D) are used to produce bias voltages \( V_{UP EE_D} \) and \( V_{DN EE_D} \) that set higher impedance modulated path while disabling the former pair of error amplifiers used in HP setting. And inverters that produce gate voltages, \( V_{UP HP_D} \) and \( V_{DN HP_D} \) are disabled to shut off lower impedance paths needed in HP setting only. Whether it is HP or EE setting, full swing control is achieved by parallel combination of a higher- and a lower-impedance paths emulated by the feedback loop in Fig(c). Single-ended full-swing levels can track the reference amplitudes at \( 3/4V_{REF} \) and \( 1/4V_{REF} \), thus producing gate-biasing voltages for output driver. It is worth noting that pull-up and pull-down impedance are independently controlled in all three control loops. Equalization settings with high resolution is achievable by implementing low-frequency global DACs to produce reference voltage levels at the reference voltage input to the error amplifier’s bias circuits in the replicas. This compares favorably with achieving tap value control via a highly nonlinearly segmented output stage, which requires complex pre-driver circuitry switching at the full data rate [30, 4, 31, 32]. While there is some power overhead associated
with the global analog feedback loops, power amortization in a multi-channel system minimizes the impact on the overall transmitter energy efficiency.

Shown in Fig. 4.6d is the IDAC that provide current biasing for the replica in Fig.4.6a of opposite polarity path only enabled in the HP setting. It is essential to guarantee good current matching between pull-up and pull-down output of the IDAC for the linearity of the PAM-4. Two cascode arms between M3-M4 and M5-M6 are capable of suppressing presumable current mismatch caused by substantial voltage difference between nodes X and Y, namely $V_{XY}$ [43]. Copied from pull-up output, due to the channel-length modulation ($\lambda \neq 0$) Thanks to output impedance boosted by cascoding, the current mismatch is determined by the voltage mismatch between P and Q nodes expressed by

$$I_X - I_y = \frac{1}{2} \mu_n C_{ox} \frac{W}{L} (AVDD - V_{bias} - |V_{THP}|)^2 (\lambda V_{PQ})$$

(4.11)

which, compared to the simple current mirror, $|V_{SD}|$ mismatch is suppressed to

$$V_{PQ} = \frac{V_{XY}}{(g_{m6} + g_{m6b}) r_{O6}}$$

(4.12)

The second current mismatch is challenged by NMOS $V_{DS}$ voltages as low as 31.25mV for $V_{REF} = 100$mV and $\alpha = 0.125$ to remain in saturation. In order to provide $V_{DS}$ matching between M8 and M9, a negative feedback with an error amplifier is incorporated with a low-voltage cascode current mirror to properly bias the gate of the M7.

4.5 Design Consideration

The main performance goal in the design of the transmitter is following: 1) low power, 2) maximum data-rate, 3) wide output swing range, 4) Minimizing mismatch between replica circuit and output driver. Depending on the target performance, one or more of these metrics will affect the design choices and sizing of the transistors in the output driver.

The width of the output driver NMOS transistors is usually determined by the trade-offs mentioned above whereas the channel length of the transistors are set to minimum. Since the impedance of the channel is generally 50-$\Omega$ single-ended equivalent, these output driver transistors are usually
large for its relatively low on-resistance. As discussed earlier, however, having a large MOS-FET switch will increase the dynamic power consumption due to the fan-out requirement of the pre-driver stage. Therefore, there is unfavorable tradeoff between the matching requirement and dynamic power consumption. Systematic approach to designing optimal energy-efficiency is provided in the following subsections.

4.5.1 Low Dynamic Power

An energy packet per cycle results in a dynamic power dissipation as defined by (2.1) where a half of it is consumed in charging the load capacitance and the other half in dissipated while discharging. Therefore, the energy cost is defined as,

\[ E = C_L V_{DD}^2. \]  \hspace{1cm} (4.13)

In order to minimize the dynamic power in the pre-driver stage that drives non-segmented output stage shown in Figure 4.8, it is best to minimize the size of switched NMOS transistors that are...
Figure 4.9: Parasitic elements in a differential termination scheme on transceiver [9].

switched by discrete voltage level as seen in Figure 4.11 such that parasitic capacitance on the gates seen by predrivers is small.

4.5.2 Maximum Data-rate

The maximum data-rate of the transmitter is defined by the time-constant at the final output node. For simplicity, when the ideal transient input by the predriver is applied to the transmit driver input as depicted in Figure 4.10a, the output voltage of the transmit driver can be derived as,

\[ V_{TXP}(t) = V_{REF} \left( \frac{3}{4} - \frac{1}{2} e^{-\frac{t}{R_{UP,TOT}C}} \right), \]  

(4.14)

where \( V_{TXP}(t) \) is single-ended output of the positive polarity, \( R_{UP,TOT} \) is total output resistance of pull-up path, and \( C \) is the capacitance seen at the output node accounting for capacitance due to ESD diode, parasitic gate-to-source and source-to-substrate capacitances as illustrated in Figure 4.9.
Figure 4.10: Illustrations of the maximum data-rate achievable by lowerbound settling time at 95% of steady-state response generated by transmit equalizer driven by pre-driver with an (a) Ideal transient-response, and (b) A realistic transient-response.
In order to set the settled output swing, the rule-of-thumb steady-state swing of \( V_{TXP}(t) \) for signal integrity is defined by 95 percent of \( 3/4V_{REF} \), thus,

\[
0.95 \times \frac{3}{4}V_{REF} = V_{REF} \left( \frac{3}{4} - \frac{1}{2} e^{-\frac{t_{95\%}}{R_{UP,TOT}C}} \right)
\]

where the \( t_{95\%} \) should be under 1-UI. Therefore,

\[
t_{95\%} = R_{UP,TOT}C \ln 13.3 < 1UI
\]

From the observation in (4.16), it is clear that the maximum data-rate can be achieved only by minimizing the capacitance seen at the output. So, it is critical to minimize the width of switching MOSTETs at the output driver not just to reduce the dynamic power consumption but to achieve the higher data-rates. Practically speaking, as shown in Figure 4.10b the realistic transient response with the finite rising time in the pre-driver will extend settling time, \( t_{95\%} \) to \( t_{95\%}' \). For the energy-efficient impedance-modulated setting, \( R_{UP,TOT} \) could be as high as 320-\( \Omega \), the maximum data-rate could be reduced by the higher time-constant at the output node unless the output capacitance is far dominated by packaging parasitic.

### 4.5.3 Maximum Output Swing

A simple analysis is performed to show the maximum differential output swing of the VM output driver. It is clear that the maximum and minimum voltage outputs at each polarity are \( 1/4V_{REF} \) and \( 3/4V_{REF} \), respectively. Due to the constraint of keeping all NMOS transistors in deep-triode region by definition,

\[
V_{DS} \ll V_{GS} - V_{THN}.
\]

In order to write a rule-of-thumb deep-triode condition,

\[
V_{DS} < \frac{1}{5} (V_{GS} - V_{THN})
\]
where $V_{GS}$ and $V_{THN}$ are gate-to-source voltage and NMOS threshold voltage, respectively. However, this requirement is too stringent to meet, therefore, the linear region can be redefined with a relaxed fraction of overdriver voltage [9]

$$V_{DS} < \frac{1}{2}(V_{GS} - V_{THN}).$$

(4.19)

![Figure 4.11: Simplified output driver segment with input signal profile.](image)

In order to find the maximum differential output swing in the linear region, the worst condition can be tested at the pull-up path since the $V_{GS}$ is less but the $V_{THN}$ is higher than pull-down NMOS transistor whose body is tied to substrate, and thus lower overdrive voltage. Therefore larger NMOS transistors are normally used for upper double-stack NMOS transistors. Next, with
the double-stack NMOS segment in the output driver shown in Figure 4.11, the analysis is a little more complex adding some degree of freedom. By defining condition based on (4.19), for the upper NMOS transistor to be in the linear region,

\[ V_X - \frac{3}{4} V_{\text{REF}} < \frac{1}{2} \left( V_R - \frac{3}{4} V_{\text{REF}} - V_{\text{THN1}} \right) \]  

(4.20)

and for the lower transistor,

\[ V_{\text{REF}} - V_X < \frac{1}{2} (V_G - V_X - V_{\text{THN2}}) \]  

(4.21)

where the \( V_X \) is the node voltage between those two NMOS transistors. By combining (4.20) and (4.21),

\[ V_{\text{REF}} < \frac{4}{13} (2V_G + V_R - V_{\text{THN1}} - 2V_{\text{THN2}}) \]  

(4.22)

assuming \( V_{\text{THN1}} = V_{\text{THN2}} = 400 \text{mV} \) with the level-shifted \( V_R = DVDD + V_{\text{THN}} \), the theoretical output swing level with linearity can be calculated as high as 523mV. It is shown that level-shifted pre-driver output not only relaxes the size constraint of the output driver’s switching transistors but also raise the output swing level allowing extended linear range.

4.5.4 Minimization of Mismatch

The question is how to optimize the performance and energy-efficiency with sizing of the final stage where the double-stack NMOS transistors in series on each signal path of the output driver form a relatively low impedance as,

\[ R_{\text{UP,TOT}} = R_{\text{UP1}} + R_{\text{UP2}} \]  

(4.23)

where the \( R_{\text{UP1}} \) and \( R_{\text{UP2}} \) are on-resistance of lower and upper NMOS double-stack transistors on pull-up segments. Again, the worst condition is assumed at \( V_{\text{TXP}} = 3/4 V_{\text{REF}} \) on the low pull-up impedance. Using deep-triode approximation explained in [43], the \( R_{\text{UP1}} \) and \( R_{\text{UP2}} \) as shown in
Figure 4.12: Gate tuning voltage needed for varying peaking ratio: (a) Impedance sensitivity with varying control voltage and (b) Gate-control voltages on all impedance paths.
the Figure 4.11 can be expressed as,

\[
R_{UP1} = \frac{1}{\mu_n C_{ox} (W_{UP1}/L_{min}) (V_{Predrv} - V_{TXP} - V_{THN1})},
\]

(4.24)

and

\[
R_{UP2} = \frac{1}{\mu_n C_{ox} (W_{UP2}/L_{min}) (V_{G,ctrl} - V_X - V_{THN2})}
\]

(4.25)

where the \(V_{Predrv}\) is the discrete level-shifted pre-driver output voltage when the logic is high, \(V_X\) is the node voltage between upper and lower NMOS transistors, and \(V_{G,ctrl}\) is the gate voltage generated by inverter whose supply voltage is provided by an error amplifier in the impedance control loop. For large \(V_{DS}\) the deep-triode approximation becomes no longer valid as the DC resistance that determine the accurate swing and equalization control when utilizing impedance control loop and AC resistance that is critical for instantaneous change of impedance level by switching [44, 45].

\[
V_{ctrl} = V_X + V_{THN2} + \frac{W_{UP1} (V_{Predrv} - V_{TXP} - V_{THN1})}{\mu_n C_{ox} W_{UP1} R_{UP,TOT} (W_{UP2}/L_{min}) (V_{Predrv} - V_{TXP} - V_{THN1}) - W_{UP2}}
\]

(4.26)

In any given MOSFET technology, the variance of \(V_{TH}\) amaong adjacent transistors reduced inversely with the gate area. This is the Pelgrom’s law known by

\[
\sigma_{V_{TH}}^2 = \frac{A_{V_{TH}}^2}{2WL}
\]

(4.27)

where \(A_{V_{TH}}\) is a process-dependent constant. If we assume the difference between two random variables \(V_{TH1}\) and \(V_{TH2}\) are uncorrelated, we can write the Pelgrom’s law as follows,

\[
\sigma_{\Delta V_{TH}}^2 = \sigma_{V_{TH1}}^2 + \sigma_{V_{TH2}}^2,
\]

(4.28)

where \(\Delta V_{TH} = V_{TH1} - V_{TH2}\).

71
Similar principle applies for the current gain factor, usually known as $\beta = \mu_n C_{ox} \frac{W}{L}$. Therefore,

$$\sigma_{\Delta \beta} = \frac{A_\beta}{\sqrt{WL}}.$$  \hspace{1cm} (4.29)

Figure 4.13: Simulated impedance mismatch between output driver and its replicas with (a) Small size analog impedance controlled NMOS ($0.8 \times W_2$) and (b) Large size ($1.2 \times W_2$).
In order to reduce the mismatch we will only increase $W$ in quadratic scale according to the Pelgrom’s law while the channel-length of all NMOS transistors are kept minimum for highest bandwidth. The gate-voltages on upper and lower NMOS transistors on the pull-up path are continuously impedance-controlled and discrete switching. It is desirable to have minimum size NMOS for the switching NMOS transistor and large one for the impedance controlled NMOS transistor for reducing the mismatch. At the same time tuning gate-voltage produced by impedance control loops should be bounded within the output swing level of the error amplifier used in the impedance control loops.

It is difficult to keep the all NMOSs in the transmit driver in the linear region over a wide range of output impedance values. Figure 4.12 shows the simulation results of resulting gate-voltage for varying width of impedance-controlled upper NMOS transistor and lower switched NMOS transistor over the 2-tap FFE peaking ratio range from 2 to 12-dB. Improper sizing of MOSFETs
in the output driver and the replicas will lead the impedance to be out of the specification because
the tuning voltage at the gate may not be tuned close to the center of the spec.

From (4.23), (4.24), and (4.25), it can be observed that for small \( W_{UP1} \) for low parasitic capac-
itance seen by pre-driver and output node, the size burden is moving to the upper NMOS transistor
where the continuous gate voltage is tuned by impedance control loop. Excessively large NMOS
used for low mismatch will result in voltage insensitive impedance tuning. Shown in Figure 4.13
is validation of variance of matching between replicas and output driver through Monte Carlo
simulations.

4.6 Measurement Results

A prototype chip is fabricated on 65nm general-purpose CMOS technology and the chip mi-
crograph is shown in Fig. 4.14. A differential 1/2-rate external clock source is used for triggering
and clocking input (Figure 4.15). A built-in PRBS generator to facilitate testing is used. Two-
channel transmitters are implemented in order to verify potential capability for high-density I/O
port for power amortization of the global impedance control loops and for full transceiver testing.
with forwarded-clocking [46, 38]. Each transmitter channel occupies 0.029m$m^2$ and entire global impedance control loops 0.031m$m^2$. In order to minimize the time-constant induced by wiring parasitic coupling, four parallel switched transistors (M1-M3 in Fig. 4.5) in the output stage that utilize output multiplexing are placed adjacent to each pre-driver and level-shifter bundle’s output. The chip is mounted on the PCB utilizing chip-on-board packaging to minimize bonding inductance. Four different lengths of PCB channels are used in order to characterize the transmitter with various insertion loss levels for wide range of speed as shown in Fig. 4.16. The I/O channels consist of 1.3", 10", 16", and 28" RO4350B channel with grounded coplanar waveguide (GCPWG), and end-launch SMA connectors.

The global impedance modulation loops precisely control the required 2-tap FFE weight for the configurable TX equalization range 2~12dB across the tunable swing level 100~400mV$_{ppd}$. In the EE setting, transmit driver path impedance for de-emphasis relative to the peaking ratio (Fig. 4.17b) is obtained by measuring the output voltage level using a low-speed fixed pattern

![Figure 4.16: S-parameters of test channel.](image-url)

![Graph showing S-parameters of test channel.](image-url)
Figure 4.17: (a) Measured equalization impedance mapping in the EE mode. (b) Transmitter output overlay of de-emphasis levels between 2~12dB with fixed pattern running at 8-Gb/s.

with only short IO channel on the prototype PCB. The deviation from the theoretical impedance is confined to 11.4% at $\alpha = 0.375$ (12dB) as shown in Fig. 4.17a. A time-domain overlay of the TX output transmitting a fixed pattern of bit-stream ("00111000101011") at 12-Gb/s, presenting
Figure 4.18: Measured NRZ TX output eyes and jitter performance with FR-4 channel, $2^{15} - 1$ PRBS, (a) at 16Gb/s in HP mode, (b) at 16Gb/s in EE mode, (c) at 20Gb/s in HP mode, (d) at 20Gb/s in EE mode

its effectiveness to provide high-resolution and wide-range control of de-emphasis with analog impedance control loops.

Fig. 4.18 shows the equalized eye-diagrams and jitter performance of the 16 Gb/s and 20 Gb/s NRZ $2^{15} - 1$ PRBS pattern measured from a real-time oscilloscope after 16" RO4350B channel in both HP and EE settings. Given as performance constraints to demonstrate scalable power-efficiency over data rate, 50 mV eye-height and 1/2-UI eye-width are chosen [29]. The deterministic jitter (DJ) and random jitter (RJ) are 21.41 ps and 330 fs in the 20 Gb/s HP setting and 26.06...
Figure 4.19: Measured PAM-4 TX output eyes with 1" FR-4 channel, $2^{15} - 1$ PRBS, (a) with phase calibration at 16Gb/s (b) with level density histogram at 16Gb/s (c) with phase calibration at 28Gb/s (d) with level density histogram at 28Gb/s

ps and 780 fs in the EE setting in NRZ mode, respectively.

The scope measures transmitter’s PAM-4 operations at 16-Gb/s and 28-Gb/s rate over a 1.3" RO4350B channel, as shown in Fig. 4.19. The DCC and QEC circuitry allows for uniform eyes out of the 1/4-rate transmitter. There is much debate within standards study group on newly defined measurement protocols on PAM-4 linearity, jitter analysis, and accordingly test equipment configurations [19] In order to quantify the linearity of PAM-4 operation, we conducted vertical histogram measurements that yield 95% and 94.7% level separation mismatch ratio (RLM) at 16-Gb/s and 28-Gb/s rates, respectively, thus the analog-control approach is validated to ensure linearity of the PAM-4 levels in the low-swing VM mode transmitter.
Table 4.2: Transmitter Power Breakdown

<table>
<thead>
<tr>
<th></th>
<th>NRZ (8Gb/s, 28&quot;)</th>
<th>NRZ (20Gb/s, 16&quot;)</th>
<th>PAM-4 (28Gb/s, 1.3&quot;)</th>
</tr>
</thead>
<tbody>
<tr>
<td>Global Clocking Buffer [mW] (amortized across 2 TX)</td>
<td>1.5</td>
<td>1.4</td>
<td>1.4</td>
</tr>
<tr>
<td>Serializer, Encoder, Clock [mW]</td>
<td>3.2 (DVDD=0.7V)</td>
<td>12.5 (DVDD=1.05V)</td>
<td>7.0 (DVDD=910mV)</td>
</tr>
<tr>
<td>Global Impedance Control, IDAC &amp; Voltage Regulator [mW] (amortized across 2 TX)</td>
<td>EE</td>
<td>HP</td>
<td>EE</td>
</tr>
<tr>
<td>Pre-drivers [mW]</td>
<td>2.2</td>
<td>5.8</td>
<td>2.2</td>
</tr>
<tr>
<td>Transmit Driver [mW]</td>
<td>1.9</td>
<td>2.7</td>
<td>11.1</td>
</tr>
<tr>
<td></td>
<td>2.2</td>
<td>2.9</td>
<td>2.3</td>
</tr>
<tr>
<td>Total Energy Efficiency [pJ/b]</td>
<td>1.37</td>
<td>2.01</td>
<td>1.48</td>
</tr>
</tbody>
</table>

While power supplies are separated for measurement yet local clock distribution network, serializer, encoder, and pre-driver stages share the same supply voltage. Table 4.2 shows the power breakdown for the 20-Gb/s NRZ and 28-Gb/s PAM-4 case, and 8-Gb/s operation over lossy 28" channel. Signaling inefficiency and additional static power caused by the replica bias circuitry for opposite polarity path control in the HP setting (Fig. 4.6a) and its IDAC (Fig. 4.6d) producing matching pull-up/down currents for biasing impose power overhead in the HP mode in return for proper termination to the channel. For the dc-balanced PRBS sequence the dynamic power consumption could be reduced by 25% in the EE setting as the encoder logic circumvents unnecessary switching of pre-drivers for data run-length greater than one thereby lowering activity factor. Fig. 4.20a compares power dissipations of transmitter driving short and long backplane channels between EE and HP settings for wide range of data-rates in NRZ operations. As the data-rate escalates, the overall power consumption is dominated by dynamic power whereas the static power does not scale by bandwidth but by output swing and de-emphasis level. The scalable supply voltages are configured 700mV, 875mV, and 1.05V at 8, 16, and 20-Gb/s, respectively. The energy-saving in the EE mode is more eminent for driving more lossy channel where the required output swing and peaking ratio are higher to achieve the aforementioned performance constraints.
### Table 4.3: Transmitter NRZ and PAM-4 Performance Comparison

<table>
<thead>
<tr>
<th>Ref.</th>
<th>Y. Song (ISSCC’14)</th>
<th>K. Fukuda (JSSC’10)</th>
<th>Y. Lu (CICC’12)</th>
<th>G. Jeong (JSSC’16)</th>
<th>P-C. Chang (ISSCC’14)</th>
<th>This work</th>
</tr>
</thead>
<tbody>
<tr>
<td>CMOS Technology</td>
<td>65nm GP</td>
<td>65nm Digital</td>
<td>65nm LP</td>
<td>65nm GP</td>
<td>65nm Digital</td>
<td></td>
</tr>
<tr>
<td>Modulation</td>
<td>NRZ</td>
<td>NRZ</td>
<td>NRZ</td>
<td>NRZ</td>
<td>PAM-4</td>
<td>NRZ</td>
</tr>
<tr>
<td>Data-rate [Gb/s]</td>
<td>16</td>
<td>12.5</td>
<td>10</td>
<td>20</td>
<td>60</td>
<td>20</td>
</tr>
<tr>
<td>$V_{out}$ [mVppd]</td>
<td>300</td>
<td>320$^2$</td>
<td>250</td>
<td>250</td>
<td>250</td>
<td></td>
</tr>
<tr>
<td>Equalization</td>
<td>2-tap</td>
<td>2-tap</td>
<td>2-tap</td>
<td>2-tap</td>
<td>3-tap</td>
<td>2-tap</td>
</tr>
<tr>
<td>Channel Loss @ Nyquist [dB]</td>
<td>-15.5</td>
<td>-12.1</td>
<td>-13</td>
<td>-12</td>
<td>-2</td>
<td>-16.8</td>
</tr>
<tr>
<td>Power [mW]</td>
<td>15.3$^1$</td>
<td>6.2$^3$</td>
<td>11</td>
<td>26.8</td>
<td>206.2$^5$</td>
<td>29.5(EE)</td>
</tr>
<tr>
<td>Total Efficiency [pJ/bit]</td>
<td>0.96</td>
<td>0.49</td>
<td>1.10</td>
<td>1.34$^4$</td>
<td>3.43</td>
<td>1.48(EE)</td>
</tr>
</tbody>
</table>

1, 2: Global clock distribution is excluded.
3: 6.6dB pre-emphasis is taken into account.
4: PLL is excluded. PRBS generator running at 2.5-Gb/s is not excluded.

Impedance control loop for opposite polarity path control and IDACs are disabled and dynamic power is reduced due to the reduction of pre-driver power with the lower activity factor. However, static power dissipation due to the signaling and impedance control loops remain fairly constant regardless of data-rate change in PAM-4 operation as shown in Fig. 4.20b. Dynamic power consumption is kept low in 28-Gb/s PAM-4 operation with 1/2-symbol rate and relaxed timing margin allowing lower supply voltage at 910mV. Sub-mW/Gb/s power consumption is achieved in PAM-4 up to 28-Gb/s operation. Despite the hardware overhead introduced by dual-mode reconfigurability and additional stage at the early serialization stage rendering sixteen parallel input instead of eight used in [29], the energy efficiency is higher at 16-Gb/s EE setting thanks to output multiplexing with reduced supply voltage and smaller loading capacitance seen by the pre-drivers. The performance of low-swing (VREF < 0.5VDD) NRZ and PAM-4 transmitters in literature are summarized in Table 4.3. From the best of our knowledge, this transmitter is the first low-swing dual-mode NRZ/PAM-4 transmitter for moderate channel loss compensation.
4.7 Chapter Summary

A low-power reconfigurable NRZ/PAM-4 transmitter. The dual-mode operation on a single PHY is achieved by reusing a multitude of redundant building-blocks between NRZ and PAM-4. Performance scalability in NRZ modulation allows higher energy-efficiency on applications where the insertion loss variation tolerance is high by shutting off the opposite polarity path control loop and associated IDAC. Higher signal integrity can be accomplished by providing impedance match to the channel in the high-performance NRZ setting. Signaling efficiency coupled with dynamic power saving thanks to the elimination of wasteful switching in the pre-driver stage is effective in the energy-efficient mode.
Figure 4.20: Power breakdown for scalable bandwidth in, (a) NRZ and (b) PAM-4.
5. CONCLUSIONS AND FUTURE WORK

5.1 Conclusion

Scalable voltage-mode transmitters which offers low static power dissipation and adopts an impedance-modulated 2-tap equalizer with analog tap control, thereby obviate driver segmentation and reducing pre-driver complexity and dynamic power. Energy efficiency is further improved with capacitively driven low-swing global clock distribution and supply scaling at lower data rates, while output eye quality is optimized at low supply voltages with automatic DCC/QEC phase calibration of the local ILO-generated rail-to-rail quarter-rate clocks. A prototype fabricated in a general purpose 65 nm CMOS process includes a 2 mm global clock distribution network and two transmitters that support an output swing range of 100-300 mV with up to 12 dB of equalization. The transmitter achieves 8-16 Gb/s operation at 0.65-1.05 pJ/b energy efficiency.

Secondly, low-power dual-mode NRZ/PAM-4 differential low-swing voltage-mode transmitter exhibits a quarter-rate output multiplexing architecture for low-power operation. The output multiplexing architecture allows for low-power operation at increased up to 20-Gb/s NRZ and 28-Gb/s PAM-4 data rates. With the double-stack NMOS transistors used in the output driver and replicas, the capacitance looking into the output driver could be greatly reduced. In NRZ mode, 2-tap feed-forward equalization is realized with analog replica-bias tap control that is configurable in high-performance controlled-impedance or energy-efficient impedance-modulated settings. This analog control also allows for efficient generation of the middle levels in PAM-4 operation. Fabricated in GP 65nm CMOS, the transmitter supports an improved output swing range of 100-400mV_{ppd} with up to 12dB of equalization in NRZ mode and achieves energy efficiencies of 1.48 and 0.91pJ/b at 20-Gb/s NRZ and 28-Gb/s PAM-4 data rates. Operation in the NRZ energy-efficient impedance-modulation setting allows for power savings of up to 32% relative to the controlled-impedance setting.
5.2 Recommendations For Future Work

By the time of finishing this dissertation, more research is being carried out as a part of multi-core interconnect system. The prototype chip is being designed on 14nm LP FinFET technology targeting 370fJ/b at 25 Gb/s NRZ. There is much room to improve this work. While the scalable supply for reduced data-rate is one of the best power-reduction contributor owing to the its quadratic saving of dynamic power, the scalable supplies were provided externally rather than internal supply regulators or DC-DC converters.

Adaptive equalization on the transmitter is being investigated by providing feedback to transmitter through back-channel if necessary regarding how to optimize TX equalization settings for signal quality. TX will send a set of test patterns and RX will evaluate for training.

Power consumption will be further reduced the with the scaled replica in the analog impedance control loops. As the scaling factor increases, the static power consumption in the replica would be reduced by the same factor. However, the larger mismatch between the replicas and the output driver for excessive power reduction will result in inaccurate control of the TX equalizer. Two high-precision SMD resistors placed off-chip is egregious hardware overhead in a dense parallel interface. It is recommended to replace them with programmable resistor bank by allowing an external resistor for reference and replicate multiple resistors by calibration circuit.
REFERENCES


